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ISOLDE 3 CONTROL LAYOUT

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FOREWORD

The presented layout is now the definitive one.

Most of the ISOLDE 3 systems are still in construction but their control philosophy has been frozen.

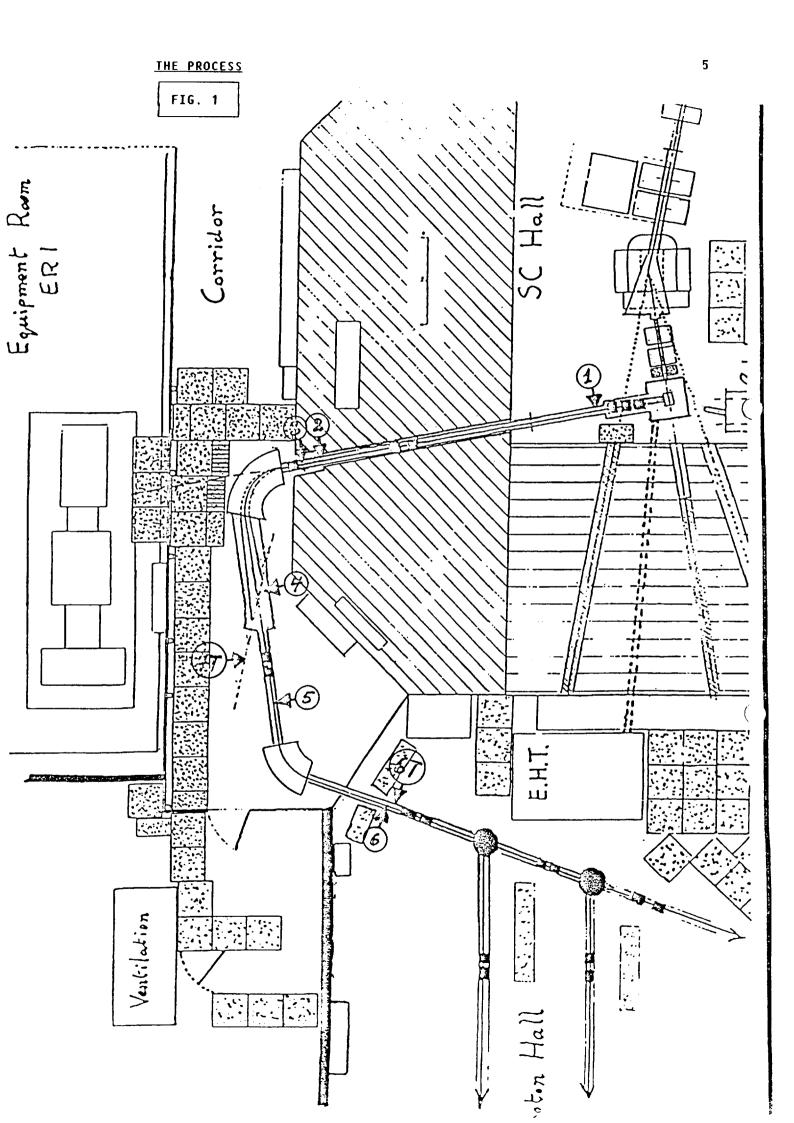
Small modifications are still possible in the future: neverthless this layout permits the different persons involved in the project to have a whole idea of what has been discussed and approved, and it can also be used as working paper for future discussions.

The ANNEXE 1 contains a description of the control computer and its hardware modules, and presents the layout of the control room with its three consoles.

In the ANNEXE 2 there is a description of the Equipment Modules (EM) and their use.

In ANNEXE 3 the use of Mac Intosh as tool for hardware test is described.

In ANNEXE 4 is contained the naming structure for ISOLDE 3 elements.



1- INTRODUCTION

1.1 Design specifications

The present layout is principally the results of a serie of meetings that the concerned people had during the spring and summer 1985.

These meetings were called I3CCM for ISOLDE 3 CONTROL COMPUTER MEETING. The meetings were obviously followed by numerous contact and informal discussions with the specialists.

The following persons participated in the discussions:

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1.2 <u>Design criteria</u>

Serial CAMAC is used as transmission system. This permits to use the large spectrum of modules existing for the PS controls.

The advantage is that a deep experience exists on this standard interface and help can be provided in maintenance and in repairing inside the division.

A particular care has been given to the maintenance problems: standardization and the function separation have proved their utility in fault diagnostics and in maintenance. For example, standardization in power supplies controls means that, independently of their different characteristics and use, they all are controled by the same hardware and software modules.

Function separation is obtained by assigning different hardware modules, or at least different registers inside the same module, to different activities or functions. In the total controls design this will cost a few extra CAMAC modules, but the software design and the fault diagnostics will be eased and improved.

Hardware and software have been designed at the same time: the results is a most homogeneous design that is optimized on both aspects considered as a whole. This is particularly important for ISOLDE 3 where the NODAL language is used: interpretive languages are slow and an appropriate hardware arrangement is required to compensate, where possible, this weakness.

The presented design is flexible and expandable. Serial CAMAC permits to easily add new crates and room is left in the existing ones.

Software modularity (Equipment Modules, sec.4.1) allows new elements of the existing type to be added in practice at no cost.

1.3 Naming structure

A naming structure, based on the so-called OSCAR BARBALAT standard (O.B.names), has been proposed and approved for the different elements of the ISOLDE 3 systems. See list in ANNEXE 4.

2- CONTROL ARCHITECTURE

2.1 <u>Computers and consoles</u>

The computer system is based on a SPS developed ICC (Independent Crate Controller) module housed in a CAMAC Crate (mother crate). This module contains a Motorola 68000 microprocessor and is used with a memory module containing the application software. In the same crate is housed a MMC (Man Machine Interface) and other modules providing facilities to drive touch screen, knobs, display, track-ball and buttons.

The only used programming language is NODAL.

More details on the control computer and console organisation are contained in ANNEXE 1.

2.2 SYSTEMS List

The identification of the different systems was done at the start of the control project.

A system is a subprocess that functionally and operationally can be controlled in an independent way. The subdivision in systems is very important for hardware layout design and for application programs implementation.

Ten separate systems have been identified:

- Vacuum system
- Analysing magnets
- Beam Transport, including:
 - quadrupoles
 - X-Y plates (dipoles)
 - deflectors (bending)

- ION source + target

- High Tension (Faraday cage)
- Isolation transformer
- Extraction electrodes movements
- Tape transport
- Beam diagnostic
- (Squirrel cage multipoles).

The last system is not included in the present layout. For the time being it is controlled in a separate way.

2.3 <u>Repartition in CAMAC LOOPS</u>

The control system has three serial CAMAC loops: each loop will be controlled via a console with interactive devices (fig.2).

<u>There are no connection between the three loops</u>. It is then essential to allocate the different systems to one or another loop in such a way that it permits concurrent control where required. In other words the main criterium is: put in the same loop systems that have not to be controlled at the same time.

The following repartition has been adopted:

- in CONSOLE 1,
 - the Vacuum system,
 - the Tape transport,
 - the beam diagnostic.

Three crates, one per each system, are installed (fig 3.)

- in CONSOLE 2,
 - the HT (Faraday cage),
 - the Isolation transformer,
 - the Ion source + Target

Two crates are installed in CONSOLE 2 (fig 4).

The first crate contains the control modules for the 60 KV of the Faraday cage and for the isolation transformer. In the second crate are housed the modules for the control of the Ion

source and the Target power supplies.

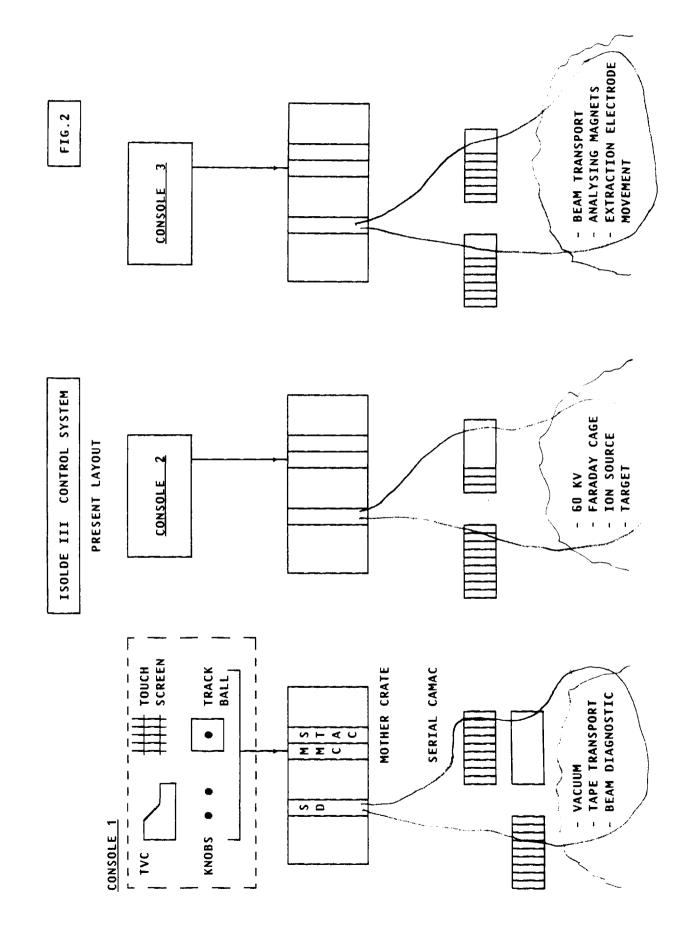
One is obliged to provide two separate crates because the second one is installed inside the Faraday cage (at a 60 KV ground level) and is connected to the loop via an optical link.

- in CONSOLE 3,

- the Analysing magnets,
- the Beam transport elements,
- the Extraction electrode movement control

Two crates are installed: the first one for the element of the separator zone and the other one for the experimental zone (fig. 5).

The subdivision eases the maintenance and permits, if required, a clean implementation of controls in slices.



CONSOLE 1

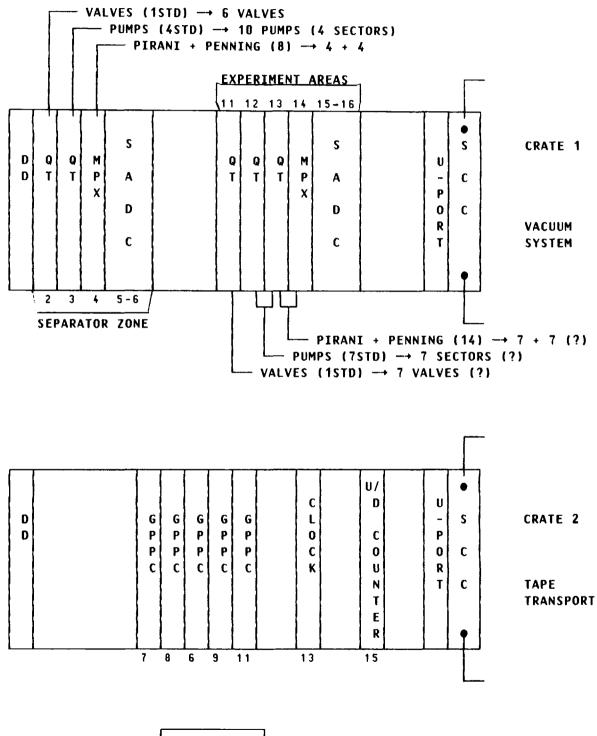
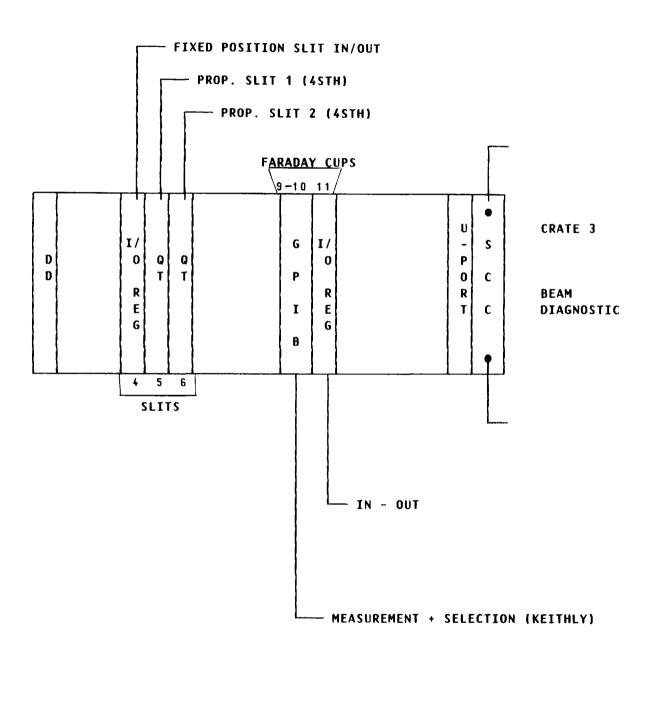
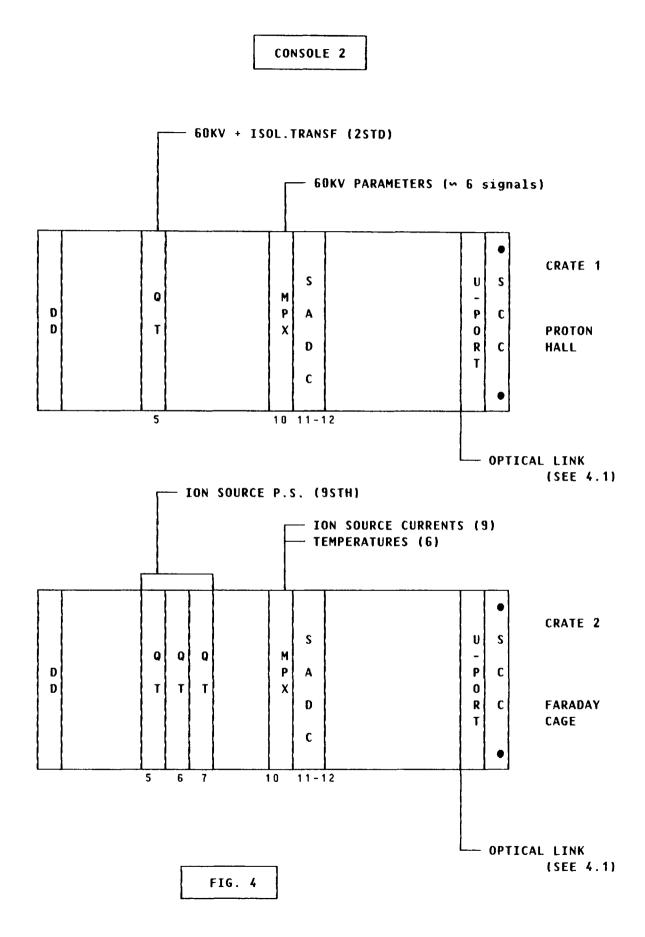
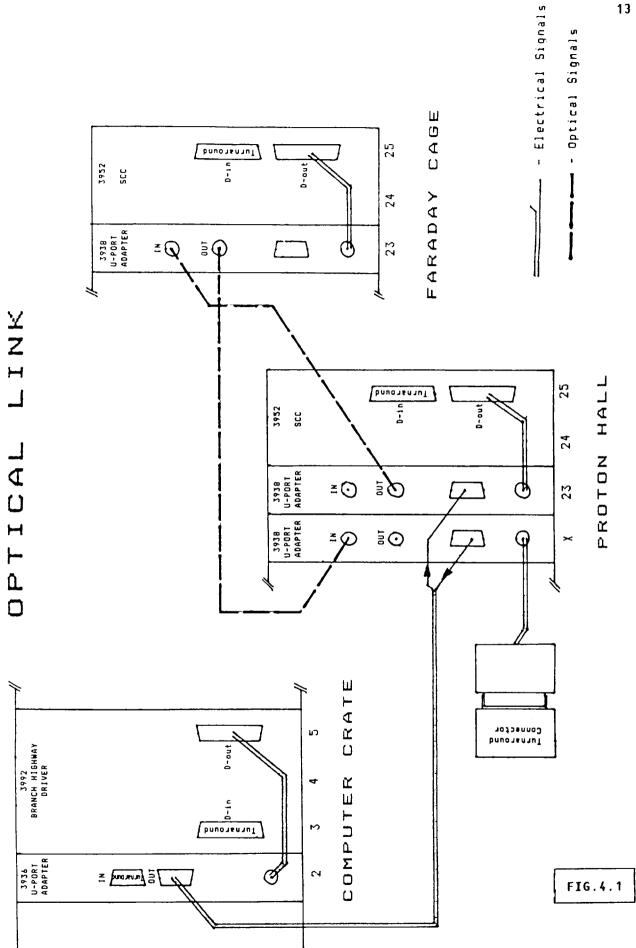


FIG. 3.1

CONSOLE 1

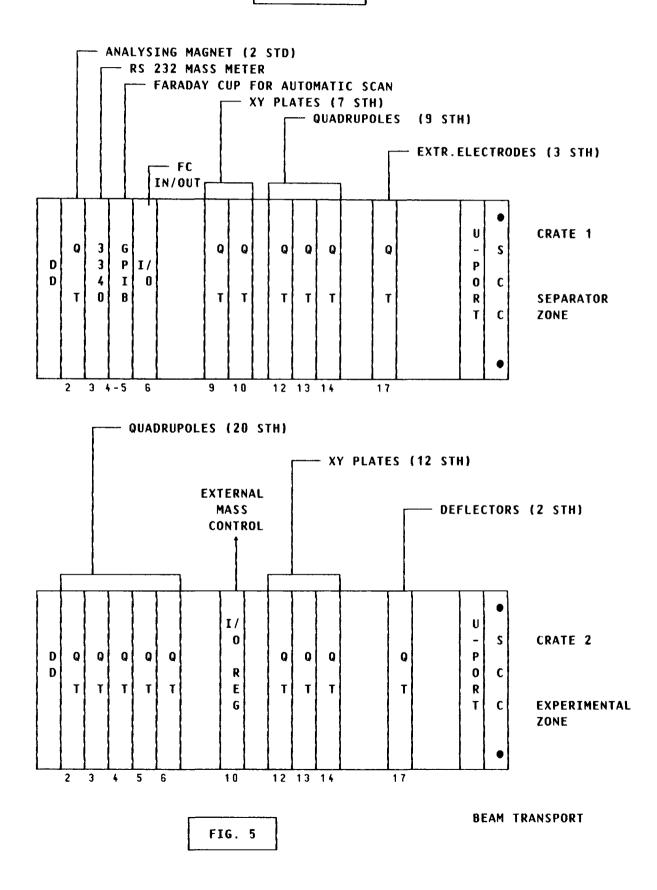






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CONSOLE 3



2.4 LOCAL CONTROL

For equipment testing, for maintenance purposes and during the commissioning period, it is very useful to have a local control facility.

In the ISOLDE 3 control system two kind of local control are foreseen:

at the level of a single equipment,
at the level of a complete CAMAC crate.

In both cases it is essential that the Main Control Room is informed if an element is in local control.

In the first case (see fig.6 for more details) each specialist should provide a manual switch permitting to connect alternatively the device to the standard control module (in the example a Single Transceiver) or to a local control. Connected to this switch there is a LOCAL/REMOTE bit activated in the register C of the Single Transceiver. In this case the SURVEY program will immediately detect and display the abnormal situation.

In the second case, it is proposed to use a mobile console based on a MACINTOSH microcomputer (see F.Di Maio, MACINTROTTE PS/CO Note 85-01). ANNEXE III.

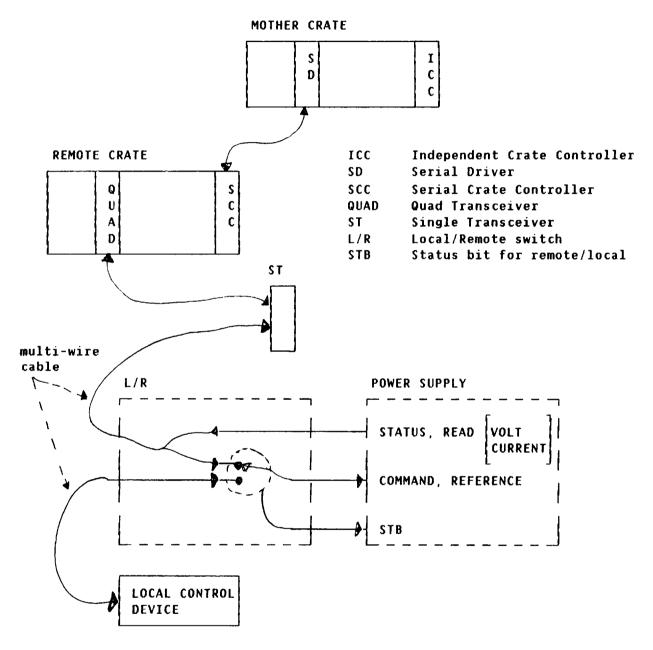
This console takes in charge a complete CAMAC crate previously disconnected from its camac loop. Using the NODAL interpreter, all CAMAC tests are then possible. In this case any application program or the Survey program will detect that the crate is disconnected and the message "SERIAL LINK DISCONNECTED" will be displayed on the concerned console.

2.5 Future Improvements

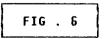
The proposed control system, based on three independent consoles driving camac loops, constitute a sufficiant answer to the basic user requirements. Neverthless this configuration has a certain number of limitations coming essentially from two characteristics of the system:

- there is no communication between the three loops,
- the ICC module provides limited real time capabilities.
- A) A program running in one console cannot have informations on parameters belonging to another CAMAC loop.
 This is a weakness, e.g., for SURVEY system that needs the acquisition of a large number of parameters to provide a minimum consequential fault analysis.
 Other examples are the measurement programs where one usually wants to adjust at the same time other parameters (beam transport, analysing magnets, source etc...)
- B) The software running in the ICC will consist of a big, monolitic NODAL program. This program is in charge of all interaction and control activities of the concerned console.

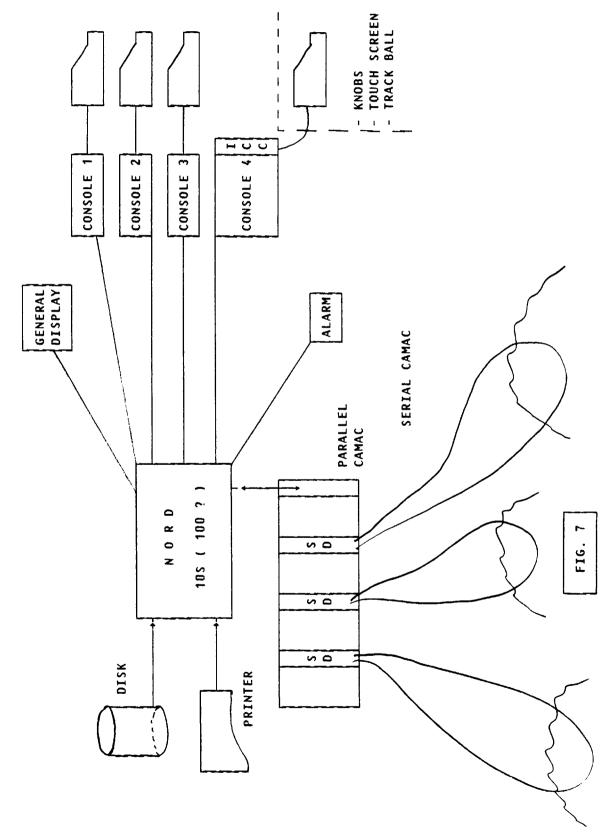
LOCAL/REMOTE CONTROL PHILOSOPHY



For local control the user has to put the L/R switch in the "LOCAL" position. This action disconnects only the command register (register A1) and the register for the reference value (register B) from the power supply. The status register (register C1 + C2) and the register for reading the voltage or the current (register D) remain active. For this reason it is possible to see in the control room what is going on locally.







In particular it has to serve the console devices (track ball, touch screen, knobs, keyboards etc...), it has to call and execute the requested applications, it has to generate the displays and the control actions etc... No scheduled tasks are allowed such as repetitive display or survey scan programs and the event driven facilities are very limited. This requires particular care in the design of the programs structure and severe restrictions are imposed to obtain acceptable execution times.

As a consequence no CLOSED LOOP CONTROL programs are advisable in such configuration, and the use of SOFTWARE INTERLOCKS is excluded. In the first case a console with its loop would be completely occupied for very long time, and in the second case no grant exists for the execution of the interlock treatment in real time.

An alternative layout design is presented in fig.7. (a similar solution has been implemented in the AA controls). A central computer (e.g. a NORD-100) communicates with the three serial CAMAC loops via a parallel crate. Up to four consoles can be connected to the computer: each console offers essentially the same facilities as the present ones.

The previously discussed limitations disappear in this configuration.

Additional advantages are:

- the CAMAC layout is not touched,
- the hardware of the consoles is essentially the same. Some minor modifications are requested in the software driving the interactive devices to adapt them to the NORD-100 system (estimation \sim 2 MM).
- Expansion to add new hardware (SC controls, beam diagnostic) are easily implemented without adding new consoles.
- the used material is in the standards of the PS/CO system: a lot of hardware and software modules can be used practically without modifications. This is particularly important for certain compiled programs (e.g. Equipment modules) that can dramatically improve the performances of the system.

It is clear that such a configuration requires some system knowledge for minor improvements and maintenance purposes: a supervisor should be named and formed. At the present it seems difficult to obtain the required personnel resources; this proposition is then valid for a possible second phase of ISOLDE 3 improvement and, may be, for the SC controls.

3- HARDWARE LAYOUT

3.1 Vacuum System

3.1.1 System description

The vacuum system is composed of a certain number of sectors separated by valves. Each sector contains: a backing pump for low vacuum and one or more turbomolecular pumps for the high vacuum.

Pressure measurements are done using two separate systems:

- Pirani gauges for values up to 10^{-5} bars.
- Penning gauges for high vacuum.

There is one Pirani and one Penning measurement per sector.

The vacuum system has been divided in seven separate sectors (fig.8 and fig.18): the first four sectors are in the separator area, the other three are in the experimental area.

The number of sectors for the experimental area can be modified in the future following other dispositions of beam lines; for this reason we foresee the control for 10 separate sectors in the present layout.

Up to now only the configuration of the first four sectors (separator area) has been specified:

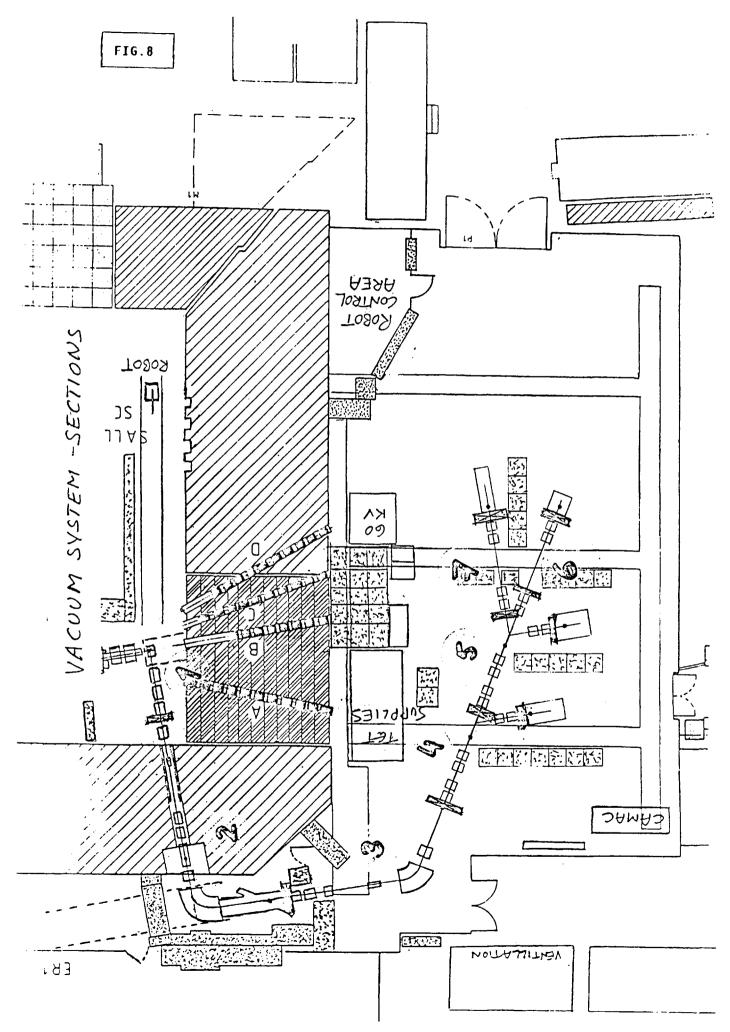
sector no.1 : one backing pump + 2 turbomolecular pumps.
sector no.2 : one backing pump + 5 turbomolecular pumps.
sector no.3 : one backing pump + 2 turbomolecular pumps.
sector no.4 : one backing pump + 1 turbomolecular pump.

3.1.2 Controlled parameters

The control of the vacuum system is done using the PS standard. Quad Transceiver (QT) and Digital Single Transceiver (STD) are used as control modules for individual command and acquisition of pumps and valves status. Multiplexers (MPX) and Scanning Analog to Digital Converters (SADC) are used to read the pressure values.

I) PUMPS

- In fig.9 is represented the use of the 4 register of a STD.
- A) Register A is used for control. Two bits (right justified) are allocated for each pump
 - 11 undefined (no action)
 - 10 pump is put ON
 - 01 pump is put OFF
 - 00 no action



The use of two bits per element permits a setting of each pump independent of the situation of other pumps in the same STD.

- B) Register B is not used.
- C) Register C is used for acquisition. Same meaning of bits as in Register A.
- D) Register D is used to acquire other status informations. Three bits are allocated per pump (right justified):

- bit 1 = 0 vacuum 0.K. ($\leq 10^{-5}$??) - bit 2 = 0 pump under computer control (REMOTE) - bit 3 = 0 pump status 0.K.

With this bit pattern, 5 pumps at a maximum can be controlled by STD. The exact generation of these bits will be given in a paper on the specific vacuum interface (Kugler). Remark: The backing pump have not status information in the register D.

II) VALVES

- In fig.9 is represented the use of the 4 register of the STD.
- A) Register A is used for control. Two bits are allocated per valve:
 - 11 undefined (no action)
 - 10 valve is put OPEN
 - 01 valve is put CLOSED
 - 00 no action
- B) Register B is not used.
- C) Register C is for acquisition with the same bit specification as for Register A.
- D) Register D is used for acquisition of Remote/LOCAL condition (one bit per valve).

With this bit pattern, 8 valves at a maximum can be controlled by STD.

3.1.3 Control Layout

All the standard modules for the vacuum system are grouped in the first crate of the CONSOLE 1 as shown in fig.3.

We have separated modules in two groups, one controlling the separator zone and the other controlling the experimental area. This separation will ease hardware and software maintenance. For the same

1 X 2 X 3 X 4 X 5 6 · 7 8	X 2 X 2 X 3 X 4 5 6 7 7	C3 Pump 2 ON C4 Pump 2 OFF C5
2 X 3 X 4 X 5 6 7 8	X 3 X 4 5 6 7	C2 Pump 1 OFF C3 Pump 2 ON C4 Pump 2 OFF C5 C6
2 X 3 X 4 X 5 6 7 8	X 3 X 4 5 6 7	C2 Pump 1 OFF C3 Pump 2 ON C4 Pump 2 OFF C5 C6
3 X 4 X 5 6 7 8	X 3 X 4 5 6 7	C3 Pump 2 ON C4 Pump 2 OFF C5 C6
4 X 5 6 · 7 8	X 4 5 6 7	Cf Pump 2 OFF C5 C6
5 6 7 8	5 6 7	C5 C6
6 7 8	7	6
7 8	7	
8	. 8	י - י
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		STROBE REG C
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╉╼╼╼╼┫	· · · · ·	ENABLE DELAY - C
4		A
44		STROBE REG D
4		REG DI Vac not OK
h		
		4
		4
	→ <u></u>	4
		4
		4
		4
<u> </u>		4
39		EXT IN COMPARATOR SUPPLY VOLTAGE REG D
140	10	MADE DECISTED D
40		MODE REGISTER D
40 41 42	41	ENABLE DELAY-D
	11 12 13 14 15 16 X 17 X 18 19 20 21 22 23 24 25 26 27 28 29 30 31 32 33 34 35 36	11 11 12 13 13 13 14 14 15 15 16 χ 17 χ 18 18 19 20 21 21 22 22 23 χ 24 χ 24 χ 24 25 χ 25 26 χ 26 27 χ 27 28 χ 28 29 29 30 31 31 31 32 32 32 33 33 33 34 34 34 35 35 35 36 36 36

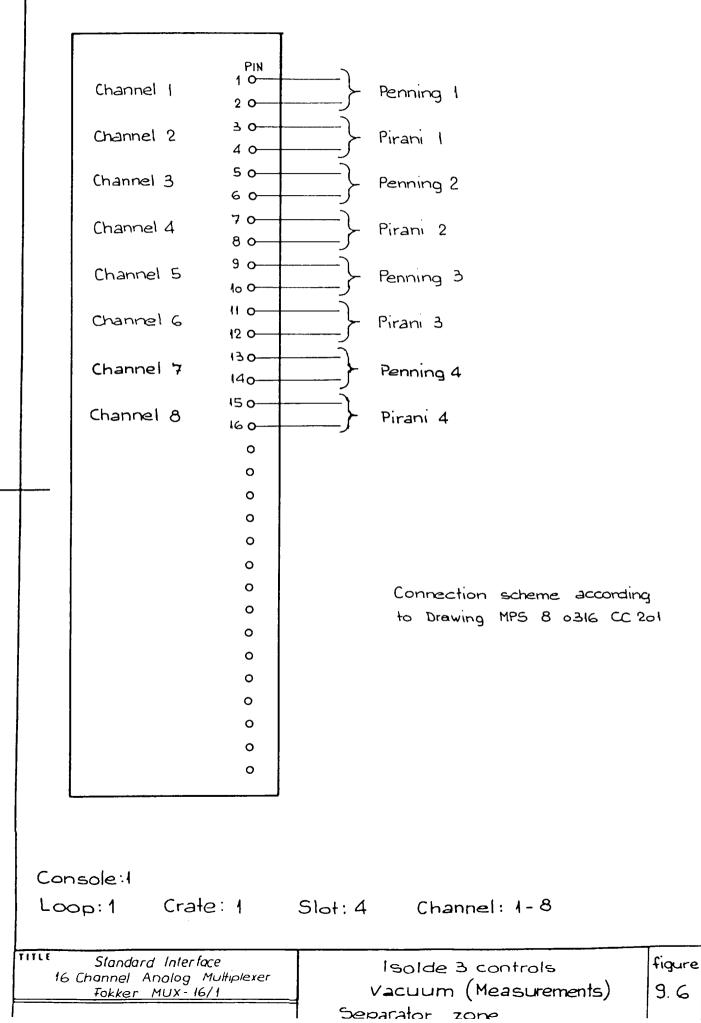
1 X 2 X 3 X 4 X 5 X 6 X 7 X 8 X 9 X		X 1 X 2 X 3 X 4 X 5 X 6 X 7 X 8	C3 Pump 4 ON C4 Pump 4 OTT C5 Pump 5 ON C6 Pump 5 OTT
2 X 3 X 4 X 5 X 6 X 7 X 8 X		X 2 X 3 X 4 X 5 X 6 X 7	C2 Pump 3 OFT C3 Pump 4 ON C4 Pump 4 OFT C5 Pump 5 ON C6 Pump 5 OFF
2 X 3 X 4 X 5 X 6 X 7 X 8 X		X 2 X 3 X 4 X 5 X 6 X 7	C2 Pump 3 OFT C3 Pump 4 ON C4 Pump 4 OFT C5 Pump 5 ON C6 Pump 5 OFF
3 X 4 X 5 X 6 X 7 X 8 X		χ 3 χ 4 χ 5 χ 6 χ 7	C3 Pump 4 ON C4 Pump 4 OTT C5 Pump 5 ON C6 Pump 5 OTT
4 X 5 X 6 X 7 X 8 X		χ 4 χ 5 χ 6 χ 7	C4 Pump 4 OFF C5 Pump 5 ON C6 Pump 5 OFF
5 χ 6 χ 7 χ 8 χ		χ 5 χ 6 χ 7	C5 Pump 5 ON C6 Pump 5 OFF
6 Χ 7 Χ 8 Χ		<u>χ</u> 6 <u>χ</u> 7	C6 Pump 5 OFF
7 χ 8 χ		X 7	
βχ			
	1		CB PUMP 6 OFF
]		EXT IN COMPARATOR SUPPLY VOLTAGE REG C
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	{		
_	{		
			4
	ł		4
	ł	h	
			STROBE REG C
+		· · · · · · · · · · · · · · · · · · ·	MODE REGISTER C
			ENABLE DELAY - C
+			STROBE REG D
4			
		<u> </u>	08 Local
		· · · · · · · · · · · · · · · · · · ·	
		<u> </u>	· · · · · · · · · · · · · · · · · · ·
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		\rightarrow \rightarrow	DIS Pump 7 status not OK DIG
(ł		EXT IN COMPARATOR SUPPLY VOLTAGE REG D
40	ł		EXTINCUMPARATOR SUPPLY VOLTAGE REG D
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	1	41	ENABLE DELAY-D
41	-	12	ENABLE DELAY-D OV (DIGITAL BOARD)
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	WRITE		· · · · · · · · · · · · · · · · · · ·	.	READ 2	24
	A				В	ł
REG AT	Pump 8 ON	1 X	<u> </u>	X /	REG CI Pump 8 ON	
A 2	Pump 8 OFF	2 X	1	X 2		
A3	Pump 9 ON	ÞΧ	1	X 3		
	Pump 9 OFF	4 X	1	X 4		
A5		5	1	5		
A6		6	1	6	<i>CG</i>	
A7		7	1	7	C7	
18		8	1	8	C8	
STROBE	E LS BYTE REGA	9	1	9	EXT IN COMPARATOR SUPPLY VOLTAGE REG C	
A 9		Ø	1	Ø	C9	
AD		π	1	11	<i>c</i> ø	
A11		12	1	12	С11	
A 12		13] .	13	C12	
A 13		14]	14	СВ	
A 14		15]	15	C14	
A 15	Section 3 ON	16 X		X 16	(15 Section 3 ON	
A 16	5 Section 3 OFF	17 X]	X 17	C16 Section 3 OFF	
STROBE	MS BYTE REG A	18		18	STROBE REG C	
EXT COH	OPEN COLLECTOR SUPPLY VOLTAGE REG A	19		13	MODE REGISTER C	
OV (DIGIT	TAL BOARD)	20		20	ENABLE DELAY - C	
		21		21		
STROBE		22			STROBE REG D	
REG B		23		χ 23	REG DI Vac not OK	
B		24		X 24		
B.		25		X 25		ĸ
B4		26		XX	04 Vac not ok	
85		27		X 27		
86		28		X 28	06 Pump 9 status not OK	
B		29		29	D7	
B		30		30		
B		31 32		31	09 D10	
_		33		32		
81				33	D11	
BI		34 35		<u> </u>	012 013	
B		35	' -	35	D13 D14	
81	/	37	ŀ	37	D15	
B1		38	ŀ	38	D16	ł
	PEN COLLECTOR SUPPLY VOLTAGE REG B	39	ŀ		EXT IN COMPARATOR SUPPLY VOLTAGE REG	
		40	ł		MODE REGISTER D	
1		41	ŀ		ENABLE DELAY-D	
	NL BOARD)	42	ľ	12		
		- 1			OV (DIGITAL BOARD)	

WRITE		READ 25
A		В
REG AI PUMP 10 ON	1 X	X 1 REG CI Pump 10 ON
A2 Pump to OFF	2 X	X 2 C2 Pump to OFF
A3	3	3 (3
A4	4	6 C4
A5	5	5 C5
A6	6	6 (6
A7	7	7 C7
A8	8	8 C8
STROBE LS BYTE REGA	g	9 EXT IN COMPARATOR SUPPLY VOLTAGE REG C
A 9	α	10 C9
AD	π	11 сю
A11	12	12 C11
A 12	13	13 C12
A 13	14	14 C13
A14	15	15 C14
115 Section 4 ON	16 X	X 16 C15 Section 4 ON
A16 Section 4 OFF	17 X	X 17 C15 Section 4 OFF
STROBE MS BYTE REG A	18	18 STROBE REG C
EXT CON OPEN COLLECTOR SUPPLY VOLTAGE REG A	19	19 MODE REGISTER C
OV (DIGITAL BOARD)	20	20 ENABLE DELAY · C
	21	21
STROBE REG B	22	22 STROBE REG D
REG BI	23	X 23 REG DI Vac not OK
82	24	X 24 D2 Local
B3	25	X 25 03 Pump 10 status not 0
84	26	26 D4
85	27	27 05
86	28 29	28 06
87 88	30	29 D7 30 D8
89	30	31 09
85	32	32 00
811	33	33 D11
B12	34	34 012
B13	35	35 013
B 14	35	36 014
815	37	37 D15
816	38	38 D16
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE REG B	39	39 EXT IN COMPARATOR SUPPLY VOLTAGE REG D
	40	40 MODE REGISTER D
	41	41 ENABLE DELAY-D
OV (D'GITAL BOARD)	42	42 OV (DIGITAL BOARD)
	43	43
Console:1 Loop:1 Crate:1	Slat:3	Channel: 4
ITLE Standard Interface		Isolde 3 controls
NGLE TRANSCEIVER DIGITAL VERS. 80303 CC		Maria (Dungan)
		vacuum (rumps)

1 X 2 X 3 X 4 X 5 X	B X 1 REG CI Value 1 open X 2 C2 Value 1 closed X 3 C3 Value 2 open
2 X 3 X 4 X	X 2 C2 Valve closed X 3 C3 Valve 2 open
2 X 3 X 4 X	X 2 C2 Valve closed X 3 C3 Valve 2 open
3 χ 4 χ	X 3 C3 Valve 2 open
4 X	No valve 2 open
	X 4 C4 Valve 2 closed X 5 C5 Valve 3 open
6 X	X 6 (6 Valve 3 closed
7 X	X 7 C7 Valve 4 open
	X 8 C8 Valve 4 closed
	9 EXT IN COMPARATOR SUPPLY VOLTAGE REG C
	X 10 C9 Value 5 open
	X 11 CD Valve 5 closed
	12 C11
13	13 C12
14	14 CB
15	15 C14
16	16 C 15
17	17 C16
18	18 STROBE REG C
19	19 MODE REGISTER C
20	20 ENABLE DELAY · C
21	21
	22 STROBE REG D
	X 23 REG DI Valve 1 local
	X 26 D2 Valve 2 local
	X 25 03 Valve 3 local
	X % 04 Valve 4 local
	X 27 05 Valve 5 local 28 06
	20 07
	30 08
	31 09
	32 010
	<u>33</u> D11
34	34 012
35	35 D13
36	36 D14
37	37 D15
38	38 D16
39	39 EXT IN COMPARATOR SUPPLY VOLTAGE REG D
40	LO MODE REGISTER D
41	41 ENABLE DELAY-D
42	42 OV (DIGITAL BOARD)
	$\beta \chi$ g $D \chi$ $\pi \chi$ 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 30 31 32 33 34 35 35 35 35 37 38 39 40

Hughes 38 pin connector ON frontpanel



reasons the control of the pumps and the valves inside a sector is performed by separate Quad Transceivers.

SEPARATOR ZONE
 One QT with one STD controls the 5 valves.
 One QT with three STD controls the 10 pumps of the zone.

We have assigned a STD to each one of the four sectors:

-	sector 1	turbo pumps 1 and 2,	+ backing pump
-	sector 2	turbo pumps 3, 4, 5, 5 and 7,	+ backing pump
-	sector 3	turbo pumps 8 and 9,	+ backing pump
-	sector 4	turbo pump 10.	+ backing pump

Two MPX and a SADC permit to read the 8 pressure values (4 penning values and 4 Pirani values).

- EXPERIMENTAL AREA One QT with one STD control 7 valves.

Two QT with 7 STD (one per sector ??) control the pump groups. One (?) MPX and a SADC are used for pressure readings. Sufficient room is left in the CAMAC crate for future extensions.

3.2 <u>HT_inside FARADAY_CAGE</u> (60 KV)

3.2.1 System Description

The Ion source complex (power supplies and its associated electronics) is kept to a variable high potential ranging from -60 KV to +60 KV: this permits the acceleration of the generated ions. To avoid electrical interferences with the external world (discharges), all this complex is surrounded by a Faraday Cage (fig.10). The physic experiments at ISOLDE 3 require a very high stabibity of the accelerating voltage.

The HT generator is composed essentially of (See VOSICKI specifications):

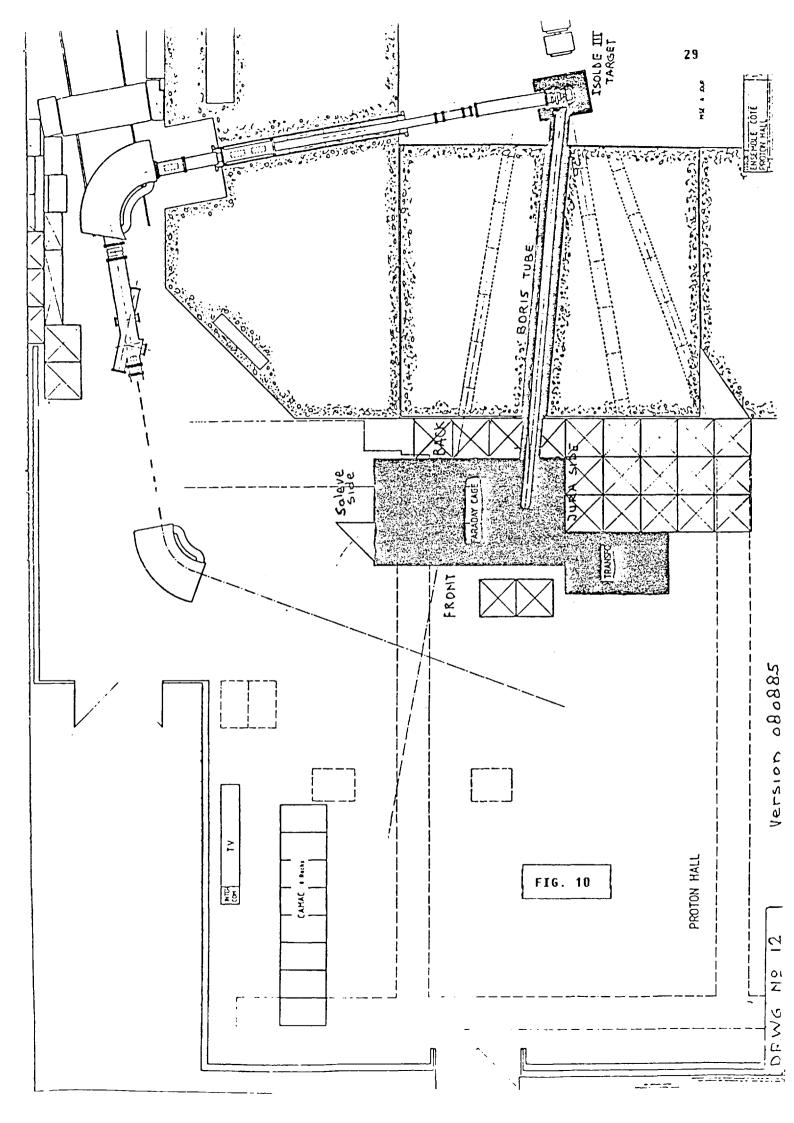
- a Rough power supply,
- a Reference power supply,
- a Stabilizer.

The stabilized HT is sent to the insulated control racks inside the Faraday Cage.

3.2.2 Controlled parameters

The rough power supply and the reference one are controlled by the same STD.

The standard actuations (ON,OFF and Stand-by) control at the same time both power supplies.



WRITE		READ 30
A		В
REG AI OFF	1 X	X 1 REG CI OFF
A2 Standby	2 X	X 2 C2 Standby
A3 ON	зχ	X 3 C3 ON
A4	4	X 4 C4 OK (no fault)
A5	5	X 5 (5 Up
A6	6	X 6 C6 Remote
A7	7	X 7 C7 N. Warning
A8	8	X 8 C8 interlock
STROBE LS BYTE REGA	9	9 EXT IN COMPARATOR SUPPLY VOLTAGE REG C
A9	Ø	10 C9
AD	n	11 CD
A11	12	12 C11
A 12	13	13 C12
A 13	14	14 C13
A 14	15	15 C4
A 15	16	[16] C 15
A16	17	17 C16
STROBE MS BYTE REG A	18	18 STROBE REG C
EXT CON OPEN COLLECTOR SUPPLY VOLTAGE REG A	19	13 MODE REGISTER C
OV (DIGITAL BOARD)	20	20 ENABLE DELAY - C
	21	21
STROBE REG B	22	22 STROBE REG D
REG BI LSB	23 X	Y 23 REG DI LSB
82	24 X	<u>X 24</u> D2
83	25 X	<u>X 25</u> 03
<i>B</i> 4	26 X	X 26 04
85	27 X	X 27 D5
86	28 X	X 28 D6
87	29 X	<u>x 29</u> 07
88 16 BIT control value	30 X	X 30 08 14 BIT acquisition value
89 810	<u>31 X</u> 32 X	
811		X 32 010 X 33 011
B12	33 X 34 X	X 34 DI2
B13	35 X	X 35 D13
B 14	35 X	X 36 D14
815	37 X	37 DI5
BIG MSB	38 X	X 38 016 Sign (1= minus)
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE REG B	39	39 EXT IN COMPARATOR SUPPLY VOLTAGE REG D
	40	LO MODE REGISTER D
	41	41 ENABLE DELAY-D
OV (DIGITAL BOARD)	42	42 OV (DIGITAL BOARD)
	43	43

Hughes 38 pin connec ON frontpanel		31
PIN PIN Channel 1 2 0 Channel 2 3 0 Channel 2 4 0 Channel 3 5 0 Channel 3 6 0 Channel 4 7 0 Channel 5 9 0 Channel 6 10 Channel 7 140 Channel 7 130 Channel 8 16 0 Channel 7 130 Channel 8 16 0 Channel 9 180 Channel 9 180 Channel 10 20 Channel 11 22 0 Channel 12 24 0 Channel 13 26 0 Channel 14 28 0 Channel 15 30 0 Channel 16 32 0	Voltage of the Rough power super lov & tokv Current of the Rough power sup lov & 40mA Voltage of the Reference power so lov & 60 KV Current of the Reference power so lov & 1mA	ply
Console: 2 Loop: 1 Crate: 1 S	Slot: 10 Channel: 1-4	
TITLE Slandard Interface 16 Channel Anolog Muttiplexer Fokker MUX - 16/1	Isolde 3 controls Go KV Parameters	figure 11.2

1 X 2 3 X 4 5 6 7 8	X 1 2 X 3 X 4 5 X 6 7	CI ON CI OK (no fault) CI CI Remote	
2 3 × 4 5 6 7 8	2 X 3 X 4 5 X 6	C2 C3 ON C4 OK (no fault) C5 C6 Remote	
2 3 × 4 5 6 7 8	2 X 3 X 4 5 X 6	C2 C3 ON C4 OK (no fault) C5 C6 Remote	
4 5 6 7 8	X 3 X 4 5 X 6	C3 ON C4 OK (no fault) C5 C6 Remote	
4 5 6 7 8	X 4 5 X 6	CH OK (no fault) C5 CG Remote	
7 8	5 X 6	C5 C6 Remote	
7 8	X 6	(6 Remote	-
7 8			
8			
ř		C8	1
9	9	EXT IN COMPARATOR SUPPLY VOLTAGE REG C	{
α	0		
 			
			1
↓		······································	
<u> </u>			-
↓ (······································	
		ENABLE DELAY · C	_
			
	4		
26		04 Oil temperature	
27			
28			
29			
30			
31			
32			
33	X 33	OII Vacuum I	
34	X 34		
35	X 35	013 High voltage	
36	36	D14	
37	37	D 15	
38	38	D16	
39			\square
40	·······		\dashv
· · ·	1 41	ENABLE DELAY-D	
41		EIVADLE DELAI D	-
41 42 43	(2)	OV (DIGITAL BOARD)	
	27 28 29 30 31 32 33 34 35 36 57 56 57 57 58 59	12 12 13 13 14 14 15 15 16 16 17 17 18 19 20 20 21 21 22 22 23 χ 24 χ 25 χ 26 χ 27 χ 28 χ 29 χ 30 χ 31 χ 32 χ 33 χ 34 χ 35 36 36 36 37 38 39 39	12 CII 13 CI2 14 CI3 15 CI4 16 CI5 17 T 18 STROBE REG C 19 MODE REGISTER C 20 20 20 ENABLE DELAY · C 21 21 22 22 23 X X 24 D2 Auxiliary voltage 1 24 X X 25 X 26 X 27 X 28 29 X X 29 X 30 <td< td=""></td<>

The setting control value is sent only to the Reference power supply: the rough power supply is set by the Reference power supply. The control value is formed of a 16 bit word without sign (sensitivity better then 10^{-5}), the acquisition has 14 bit plus a sign. Polarity is then set manually but can be read by computer. In fig. 11 are represented the 4 register of the STD with the bit meaning.

The following parameters are also acquired by computer:

- the voltage of the Rough power supply,
- the current of the Rough power supply.
- the current of the Reference power supply,
- the output voltage of the stabilizer.

The values of these parameters are adequately converted in voltages ranging from 0 to 10 V and introduced in a MPX + SADC system.

3.2.3 Control Layout

The QT and the MPX + SADC are housed in the first crate of the CONSOLE 2 as in fig. 4.

3.3 Isolation Transformer

3.3.1 System Description

As already mentionned, the nine power supplies used for the Ion source system are kept inside the Faraday Cage with a virtual hearth of about 60 KV. The mains feeding for these power supplies is produced by an oil insulated transformer located outside the Faraday cage. With a transformer ratio of 1 to 1 and a design breakdown value of 140 KV, this transformer produces the three phases required by the different power supplies.

3.3.2 Controlled Parameters

The only computer control concerns the ON/OFF command. A serie of interlock and status bits are also acquired. The control module is a STD as shown in fig. 12.

3.3.3 Control Layout

The QT is located in the first crate of the CONSOLE 2 as in fig. 4.

3.4 Target and Ion Source

3.4.1 System Description

The target and the Ion source form a compact system. Atoms of different elements are produced in a target by nuclear reaction induced by the proton beam (or He³ beam) accelerated in the synchrocyclotron.

A		1			
				В	
Α,	1	1	XI	CI OFF	<u> </u>
Az Standby	2 X	1	X		
A3 ON	3 X	1.	X	C3 ON	<u>.</u>
AL	4	7 ⊢	- X 4		
As	5		X	C5 Up	
Ac	6] L			
A7	7]		1	
Al	8]	8	СВ	
STROBE ACTUATION	9		9	EXT IN COMPARATOR SUPPLY YOLTAG	E
٨٩	10		X 10	C9 I Limit	
AD	11		11	Clo	
A 11	12		T a	2 C 11	
A 12	13	1	13	C 12	
A 13	14		16	CIS	
A 14	15		15	C 14	
A 15	16		16	C IS	
<u>Ак</u>	17		17	C16	
STROBE TEST	18	1	18	STROBE STATUS-WORD	
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	19	1		{	
OV (DIGITAL BOARD)			20	ENABLE DELAY - C	
	21	1	21		
STROBE REFERENCE OUT	22	1			
				4	
	h				
		1			
			<u> </u>		
		1			
		ł	J		
		ł	h		<u> </u>
MEASURE 1 1V # #		{			
		1			
			<u> </u>		
				·····	-
	-				
					on
	40 X				
	61		41		
	42		42	ON (DICITAL POLED)	
	43		43		
	As As As As Ar Ar STROBE ACTUATION Ag Ap Ap An Ag An An An An An An An An An An	As 5 As 6 Ar 7 AA 8 STROBE ACTUATION 9 Ag 8 STROBE ACTUATION 9 Ag 10 Ag 10 Ap 10 Ap 10 Ap 10 Ap 10 Ap 10 Ap 11 Ap 12 Ap 12 Ap 12 Ap 14 App 15 App 16 App 15 App 16 App 17 STROBE TEST 18 EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 OV (DIGITAL BOARD) 20 21 22 STROBE REFERENCE OUT 22 PASURE 12.5V * 23 MEASURE 12.5V * 23 MEASURE 12.5V * 23 MEASURE 11V * * 30 D 31	A5 5 A6 6 A7 7 A8 8 STROBE ACTUATION 9 A9 10 A9 10 A0 11 A1 12 A1 15 A1 15 A1 15 A1 15 A1 15 A1 15 A2 16 A2 17 STROBE TEST 18 EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 VI (DIGITAL BOARD) 20 21 22 STROBE REFERENCE OUT	A5 5 X 4 A6 6 X 6 A7 7 7 7 A0 8 7 7 A1 7 7 7 A1 7 7 7 A1 7 7 7 A1 7 7 7 A1 2 7 7 A11 2 7 7 A12 13 13 73 A12 13 13 13 A12 13 13 13 A13 4 14 16 16 A14 15 15 16 16 A15 16 16 16 16 A14 15 17 17 17 STROBE TEST 18 10 10 10 STROBE REFERENCE OUT 21 22 22 22 STROBE REFERENCE OUT 21	As3 X SCUpAr17CCRemoteAr17CTCAr8CBCRemoteSTROBE ACTUATION99EXT IN COMPARATOR SUPPLY VOLTAGEAr89EXT IN COMPARATOR SUPPLY VOLTAGEAr811CCAr1111CAr1111CAr1111CAr1111CAr1111Ar1211Ar1515Ar1616Ar17CAr1616Ar1515Ar16Ar17CAr17Concent Collector Supper Voltage19Mode Reference OUT122121222323242423252526262727282929202020212122232324242525272627272828292920202021222223232424252527262

	WRITE				READ 35
1	A				В
	A ;	1		X.	CI OFF
	Az Standby	2 X	1	X I	
	A3 ON	3 X	1	X	C3 ON
	AL	4] ⊢		C4 OK (no fault)
	As	5] г	- <u>x</u>	C5 Up
	Ac	6	J L	X 6	CG Remote
	A7	1	4	1	107
	AI	8	4		СВ
	STROBE ACTUATION	9	4		EXT IN COMPARATOR SUPPLY VOLTAGE
	A 9	ю	4		C9 I Limit
	A _D	"			Clo
	A ₁₁	12	-		
	A 12	13 14	-		
	A 13 A 14	15	-		C13
	A 15	16			C 14 C 15
	A 15	17	1		C16
	STROBE TEST	18	1	· · · · · ·	STROBE STATUS-WORD
	EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	19	1		MODE REGISTER - C
	OV (DIGITAL BOARD)	20	1		ENABLE DELAY - C
		21	1	21	
	STROBE REFERENCE OUT	22	1	22	STROBE MEASURE
		23	1	23	
j		24	1	24	
		ઝ]	25	
		26		25	
		27		27	
	MEASURE 15V #	28	Į	28	
	MEASURE ±2.5V #	29	Į		OV (ANALOG BOARD)
	MEASURE 1 IV # #	30	Į	30	
		31		31	
	EXT REF + OUT	32		32	
	EXT REF - OUT	33 34 X			DAC IN - REF + DAC IN - REF -
l	INT REF + OUT	35 X		× 3	
ł	OV (ANILOG BOARD) GATE EXTERNAL REFERENCE	36			COM (OV) EXTERNAL REFERENCE
ŀ	INVERIER CONTROL DAC	37			SHUNT POSITION
	POLARITY CONTROL OUT	38			POLARITY INVERTER IN
Ì	REFERENCE OUT Control	39 X		X 39	MEASURE IN + Acquisition
	OV (ANALOG BOARD) Voltage	40 X		X 40	MEASURE IN - Vollage
- r		41		41	
	OV (DIGITAL BOARD)	42		62	OV (DIGITAL BOARD)
┢		43		63	of tololine -

WRITE	<u> </u>	READ 36
A		В
Α,	1	X / CI OFF
Az Standby	2 χ	X 2 C2 Standby
AJ ON	3 X	X 3 C3 ON
AL	<u>4</u> ⊢	- X 4 C 4 OK (no fault)
A5	5	TXSC5 Up
A 6	6	L X 6 CG Remote
A 7	7	7 C 7
A	8	8 C B
STROBE ACTUATION	9	9 EXT IN COMPARATOR SUPPLY VOLTAGE
Ag	10	X 10 C9 I Limit
A D	11	<u>"Clo</u>
	12	
A 12	13	13 C 12
	15	<u>14</u> C (3
A 14	15	
A 15	16	16 C 15
A K STROBE TEST	18	17 C 16 18 STROBE STATUS-WORD
EXT COM OPEN COLLECTOR SUPPLY VOLTAG		19 MODE REGISTER - C
OV (DIGITAL BOARD)	20	20 ENABLE DELAY - C
	21	21
STRORE REFERENCE OUT	22	22 STROBE MEASURE
	23	23
1	24	24
	8	25
-	26	25
	27	27
MEASURE 15V #	21	28
MEASURE ±2.5V #	29	29 OV (ANALOG BOARD)
MEASURE : IV # #	30	30
	31	31
EXT REF + OUT	32	32
EXT REF - OUT	33	X 33 DAC IN - REF +
INT REF + OUT	34 X	X 36 DAC IN - REF -
OV (ANILOG BOARD)	35 X	35
GATE EXTERNAL REFERENCE	36	36 COM (OV) EXTERNAL REFERENCE
	37	37 SHUNT POSITION
INVERIER CONTROL DAC		
POLARITY CONTROL OUT	38	38 POLARITY INVERTER IN
POLARITY CONTROL OUT REFERENCE OUT Control	39 X	X 39 MEASURE IN+ Acquisitio
POLARITY CONTROL OUT	39 X 40 X	X 39 MEASURE IN + Acquisitio X 40 MEASURE IN - Voltage
POLARITY CONTROL OUT REFERENCE OUT Control	39 X	X 39 MEASURE IN+ Acquisitio

WRITE		<u></u>		READ	37
A	_			В	
A ;	1		X	CI	
Az Standby	2 χ]	X	C2 Standby	
A3 ON	3 X		X	C3 ON	
AL	4	⊢	- <u>X</u>		
As	5	Ιr	<u> </u>	UCS Up	
A6	6	╎└	<u> </u>	C6 Remote	
A7	7]	7	2 C7	
AI	8			СВ	
STROBE ACTUATION	9)	EXT IN COMPARATOR SUPPLY YOL	TAGE
٨٩	10		XI	C9 I Limit	
Ap	11			Clo	
A 11	12				
A 12	13		<u> </u>	C 12	
A 13	×			CIS	
A 14	15			C 14	
A 15	16			C 15	
A 16	17			C16	
STROBE TEST	18		J	STROBE STATUS-WORD	
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	19			MODE REGISTER - C	
OV (DIGITAL BOARD)	20			ENABLE DELAY - C	
	21		27		···
STROBE REFERENCE OUT	22			STROBE MEASURE	
	23		23	4	
	24		24	4	
•	25 26		25	4	
	27		27		
MEASURE 15V #	21		28	4	
MEASURE 130 # MEASURE 12.5V #	29		<u> </u>	OV (ANALOG BOARD)	
MEASURE : IV # #	30		30		
r Laoura	31		31		
EXT REF + OUT	32		32		
EXT REF - OUT	33		χ 33	DAC IN - REF +	
INT REF + OUT	34 X			DAC IN - REF -	
OV (ANILOG BOARD)	35 X		35		
GATE EXTERNAL REFERENCE	36		36	COM (OV) EXTERNAL REFERENC	ε
INVERIER CONTROL DAC	37		37	SHUNT POSITION	
POLARITY CONTROL OUT	38		38	POLARITY INVERTER IN	
REFERENCE OUT Control	39 X		X 35	MEASURE IN + Acquie	sitio
OV (ANALOG BOARD) Voltage	40 X		χ 10	MEASURE IN - Voltage	<u>-</u>
	41		41		
OV (DIGITAL BOARD)	62		42	OV (DIGITAL BOARD)	
•••	43		43		

A	_	1		
Α,				В
	1	1	X1	CI OFF
Az Standby	2 X]	X 2	C2 Standby
A3 ON	3 X]	Χ3	C3 ON
A4	4] ⊢	X 4	C4 OK (no fault)
A5	5		X 5	C5 Up
A6	6	╏└	X 6	C6 Remote
A7	7		7	-
A8	8			
			<u> </u>	EXT IN COMPARATOR SUPPLY VOLTAGE
-	10			C9 I Limit
	11	Į		Clo Temp. limit
	·	4	<u> </u>	CII
		4		C 12
		ł	h	C13
		┦		
1		+		CIS
		\mathbf{I}		CIG STROBE STATUS-WORD
		1		MODE REGISTER - C
		-		ENABLE DELAY - C
		1		
STROBE REFERENCE OUT	22	1		STROBE MEASURE
	23	1	23	
	24	1	24	
	25	1	25	
	26	1	26	
	27]	27	
MEASURE 15V #	28]	28	
MEASURE ±2.5V #	29		29	OV (ANALOG BOARD)
MEASURE ± IV * *	30		30	
	31	ļ	31	
EXT REF + OUT				
EXT REF - OUT				DAC IN - REF + DAC IN - REF -
				UAL IN TREF
	_	ſ		
				COM (OV) EXTERNAL REFERENCE
· · · · · · · · · · · · · · · · · · ·			-	POLARITY INVERTER IN
		{		MEASURE IN + Acquisition
		1		MEASURE IN - Voltage
	41	1	41	
OV (DIGITAL BOARD)	42		42	
IN THOUAL BUAKUT	43	1	43	OV (DIGITAL BOARD)
	A6 A7 A8 STROBE ACTUATION Ag Ap Ap	A_{6} δ A_{7} 7 A_{8} 8 SIROBE ACTUATION 9 A_{9} 10 A_{0} 11 A_{11} 12 A_{12} 13 A_{11} 12 A_{12} 13 A_{13} 4 A_{14} 15 A_{15} 16 A_{15} 16 A_{15} 16 A_{15} 16 A_{n6} 17 STROBE TEST 18 EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 DV (DIGITAL BOARD) 20 21 31 EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 DV (DIGITAL BOARD) 20 21 32 STROBE REFERENCE OUT 22 21 31 EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 DV (ASURE $\pm 2.5V *$ 22 MEASURE $\pm 2.5V *$ 22 MEASURE $\pm 2.5V *$ 23 <td>A_{f} f A_{J} R A_{II} R A_{III} R A_{III} R A_{III} R A_{III} R A_{IIII} R $A_{IIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIII$</td> <td>$A \in$ δ $X \in$ $A \gamma$ 7 7 $A =$ 8 8 STROBE ACTUATION 9 9 $A g$ 10 X 10 $A \mu$ 11 X 10 $A \mu$ 11 X 11 $A \mu$ 12 13 A_{12} 13 13 A_{12} 13 14 A_{14} 15 15 A_{15} 16 16 A_{15} 16 16 A_{15} 16 17 A_{15} 16 18 <math>EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 $0V (DIGITAL BOARD)$ 20 20 21 21 21 <math>STROBE REFERENCE OUT 22 22 22 22 22 23 23 24 24 25 25 25 26 25 26 25 25 26 25 25 27 27 </math></math></td>	A_{f} f A_{J} R A_{II} R A_{III} R A_{III} R A_{III} R A_{III} R A_{IIII} R $A_{IIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIII$	$A \in$ δ $X \in$ $A \gamma$ 7 7 $A =$ 8 8 STROBE ACTUATION 9 9 $A g$ 10 X 10 $A \mu$ 11 X 10 $A \mu$ 11 X 11 $A \mu$ 12 13 A_{12} 13 13 A_{12} 13 14 A_{14} 15 15 A_{15} 16 16 A_{15} 16 16 A_{15} 16 17 A_{15} 16 18 $EXT COM OPEN COLLECTOR SUPPLY VOLTAGE 19 0V (DIGITAL BOARD) 20 20 21 21 21 STROBE REFERENCE OUT 22 22 22 22 22 23 23 24 24 25 25 25 26 25 26 25 25 26 25 25 27 27 $

WRITE				READ	39
A				В	
Α,	1	<u> </u>	X I	CI OFF	
Az Standby	2 χ	1	X 2		
A3 ON	3 X	1	X 3		
A 4	4	1 ⊷	X 4		
AS	5	1	_	C5 Up	
AG	6	1 L	X 6		
A7	7	1	7		
Ad	8	1	8		
STROBE ACTUATION	9	1	9	EXT IN COMPARATOR SUPPLY YOLTAG	E
Ag	10	1		C9 I Limit	
Ap	11		<u> </u>	Clo Temp. limit	
A	12	1		C11	
	13	1		C 12	
A 13	14	1	<u> </u>	C13	
A 14	15	1		C 14	
A 15	16	ł		C 15	
	17	i		C 16	
STROBE TEST	18			STROBE STATUS-WORD	
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	19	1		MODE REGISTER - C	
OV (DIGITAL BOARD)	20	{		ENABLE DELAY - C	
	21	1	21		
STROBE REFERENCE OUT	22	1		STROBE MEASURE	
	23		23		
	24		24		
	8		25		
-	25		26		
	27		27		
MEASURE 15V #	21		28		
MEASURE ±2.5V #	29		29	OV (ANALOG BOARD)	
MEASURE 1 IV # #	30		30		
	31		31		
EXT REF + OUT	32 .		32		
EXT REF - OUT	33		X 33	DAC IN - REF +	
INT REF + OUT	34 X	\backslash		DAC IN - REF -	
OV (ANALOG BOARD)	35 X		<u>х</u>		
GATE EXTERNAL REFERENCE	36		36	COM (OV) EXTERNAL REFERENCE	
INVERIER CONTROL DAC	37			SHUNT POSITION	
POLARITY CONTROL OUT	38		38	POLARITY INVERTER IN	
REFERENCE OUT Control	39 X		X 39	MEASURE IN + Acquisi	tion
OV (ANALOG BOARD) Voltage	40 X		X 40	MEASURE IN - Voltage	
	41		61		
	42		62	OV (DIGITAL BOARD)	
OV (DIGITAL BOARD)	1			UV LUIGITAL DUARUY	

	WRITE			<u> </u>	READ
	A				В
	Α,	1	1	X 1	CI OFF
	Az Standby	2 χ]	X 2	C2 Standby
	A3 ON	3 X]	X 3	
	AL	4] ⊢	X 4	C4 OK (no fault)
	As	5] [XS	
	A6	6	ונ	X 6	C6 Remote
	A7	1	1	7	C7
	AI	8	1	8	СВ
	STROBE ACTUATION	9		·······	EXT IN COMPARATOR SUPPLY VOLTAGE
	Ag	10		X 10	C9 I Limit
	AD	<u>n</u>	1		Clo Temp. limit
	A 11	12	1		C 11
	A 12	13	1	<u> </u>	C 12
	A 13	¥	{		CIS
	A 14	15	ł		C 14
	A 15	16	{		C 15
	Ак	17	1		C16
	STROBE TEST	18	1		STROBE STATUS-WORD
	EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	19	ł		MODE REGISTER - C
	OV (DIGITAL BOARD)	20	ł		ENABLE DELAY - C
		21		21	
	STROBE REFERENCE OUT	23	{	23	STROBE MEASURE
		24	{	24	
		24 25		25	
	1	26	1	25	
		27		27	
	MEASURE 15V *	21		28	
	MEASURE ±2.5V #	29			OV (ANALOG BOARD)
}	MEASURE : IV # #	30		30	
		31		31	
	EXT REF + OUT	32 -		32	
	EXT REF - OUT	33		χ 33	DAC IN - REF +
	INT REF + OUT	34 X		χ 34	DAC IN - REF -
	OV (ANALOG BOARD)	35 X		¥	
	GATE EXTERNAL REFERENCE	36		36	COM (OV) EXTERNAL REFERENCE
- 1	INVERIER CONTROL DAC	37		37	SHUNT POSITION
					POLARITY INVERTER IN
	POLARITY CONTROL OUT	38			
	POLARITY CONTROL OUT REFERENCE OUT Control	38 39 X		X 39	MEASURE IN+ Acquisition
		38 39 X 40 X		χ 39 χ 40	MEASURE IN + Acquisition MEASURE IN - Voltage
	REFERENCE OUT Control	38 39 X		X 39	TENSOTIE

-	A)		H
					В
-	4,	1	-	X 1	
- H	Standby	2 X	4	X 2	
- F	43 ON	<u>3 X</u>	-	· · · · · · · · · · · · · · · · · · ·	C3 ON
	42	4	-	X 4	
	4 <i>5</i>	5	$+$ \square		C5 Up
	1¢ 1-	6	1		C6 Remote
	4 7 1 A	8	-	<u> </u>	C7 C8
- H-	STROBE ACTUATION	9	{		EXT IN COMPARATOR SUPPLY VOLTAGE
Ē	1g	10	-	V 10	C9 I Limit
	•9 4 ₁₀	11	-		Clo Temp. limit
	4 <i>11</i>	12	{		Clo serrip. limit
	12	13	1	<u> </u>	C 12
	13	к	1	J	C13
	14	15	1		C 14
	15	16	1		C 15
	к	17	1	}	C 16
	STROBE TEST	18	1	<u> </u>	STROBE STATUS-WORD
E	XT COM OPEN COLLECTOR SUPPLY VOLTAGE	19	1	19	MODE REGISTER - C
0	IV (DIGITAL BOARD)	20	1	20	ENABLE DELAY - C
	<u></u>	21	1	21	
5	TROBE REFERENCE OUT	22	1	22	STROBE MEASURE
		23	1	23	
		24]	24	
		ষ]	25	
		26		25	
		27		27	
~	IEASURE 15V #	28		28	
1	IEASURE ±2.5V #	29		29	OV (ANALOG BOARD)
	MEASURE 1 IV # #	30		30	
		31		31	
6	EXT REF + OUT	32 .		32	
	EXT REF - OUT	33			DAC IN - REF + DAC IN - REF -
	NT REF + OUT	34 X		<u> </u>	
-	NY (ANILOG BOARD)	35 X		35	
	ATE EXTERNAL REFERENCE	36 37			COM (OV) EXTERNAL REFERENCE
—	IVERIER CONTROL DAC	37			POLARITY INVERTER IN
┣	EFERENCE OUT Control	39 X			MEASURE IN + Acquisitio
1	V (ANALOG BOARD) Voltage	40 X			MEASURE IN - Vollage
F	Vollage	41		4/	
\vdash		42		42	
0	V (DIGITAL BOARD)	43	ł	43	OV (DIGITAL BOARD)
Cor	bit 4 - 0 in case of phase nsole : 2 op: 1 Crate : 2 S			C	hannel:1

1 2 X 3 X 4 5 6 7 8		X 6	C2 Standby C3 ON C4 OK (no fault) * C5 Up
2 X 3 X 4 5 6 7 8		X 2 X 3 X 4 X 5 X 6	C2 Standby C3 ON C4 OK (no fault) * C5 Up
3 X 4 5 6 7 8		X 2 X 3 X 4 X 5 X 6	C2 Standby C3 ON C4 OK (no fault) * C5 Up
4 5 6 1 8		X 4 X 5 X 6	C3 ON C4 OK (no fault) * C5 Up
5 6 7 8		X 5 X 6	C5 Up
6 7 8		X 6	C5 Up
			C6 Remote
			C7
		· · · · ·	СВ
9		· · · · · · · · · · · · · · · · · · ·	EXT IN COMPARATOR SUPPLY VOLTAGE
ю			C9 I Limit
11			Clo Temp. limit
			2 C 11
			C 12
		<u>}</u>	C13
			
			C 15
		}	STROBE STATUS-WORD MODE REGISTER - C
		<u> </u>	ENABLE DELAY - C
	i		
_		}	STROBE MEASURE
		23	
h		24	4
		25	
26	i	8	1
27		27	
21		28	
29		29	OV (ANALOG BOARD)
30		30	
31		31	
32 .		32	
33	\triangleleft		DAC IN - REF +
	\square	<u> </u>	DAC IN - REF -
+			COM (OV) EXTERNAL REFERENCE
			POLARITY INVERTER IN
↓ (MEASURE IN + Acquisition
40 X	ł		MEASURE IN - Voltage
		~	
61		4 1	
1		41 42	OV (DIGITAL BOARD)
	11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 30 31 32 33 34 35 36 37 38 39 39 39	11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 21 22 23 34 35 36 37 39 39	11 χ 11 12 13 13 13 13 13 14 14 14 15 19 16 16 16 16 17 17 17 18 18 18 19 19 20 20 20 20 21 21 21 22 22 22 23 23 23 24 24 24 25 25 25 26 28 29 30 30 30 31 31 31 32 33 χ 33 34 χ 34 35 χ 35 35 35 35 36 37 37 39 χ 34

		PIN	
Chann	iel 1	1 O	$\left\{ \begin{array}{c} \\ \\ \\ \end{array} \right\}$ Cathode current 10 V = 60 A
Chann	el 2	3 0 4 0	Electron bombardment current 10
Chann	el 3	5 o	
Chanr	nel 4	7 o 8 o	Source magnet current 10V=20,
Chanr	nel 5	9 o	Electron deflector current 10V=
Chanr	७१८	11 0	Anode 1 current 10V= 3A
Chanr	nel 7	130	Anode 2 current lov = 3A
Chann	el 8	150	Line heating current 10V= 500
Chanr	rel 9	170	-Target heating current 10V= 1 000
Chann	el lo	190 200	
Chann	el ((21 O	Front end temperature 2
Channe	el 12	23 0	Front end temperature 3
Channe	1 13	25 O 26 O	Ambient temperature 1
Channe	14	27 O	Ambient temperature 2
Channel	15	29 o	Ambient temperature 3
Channe	1 16	31 0 32 0	<u> </u>
onsole:	2		
00p:1	Cra	e: 2	Slot: 10 Channel: 1-15
Slandai 16 Channel	rd Interl Anolog		Isolde 3 controls
<u>Fokker</u>	MUX - 16	>/1	Faraday cage Measurements

Adequate heating procedures permit these atoms to migrate from the target, through the Transfer line, to the ion source. The produced atoms are ionized by an ion source.

Several types of ion sources are foreseen, each one requiring the use of a certain number of power supplies. Nine power supplies are installed in total but only a part of them is used for each configuration.

The nine power supplies are:

te pener cuppires are:	
1) Electron deflector	(3 KV)
2) Anode 1	(3 A)
3) Anode 2	(3 A)
4) Electron bombardement	(2A)
5) Oven Heating	(60 A)
6) Cathode	(60 A)
7) Source Magnet	(3 A)
8) Line Heating	(500 A)
9) Target Heating	(1000 A)

Before the start of a run with a new configuration, the specialists will manually connect (using a patch-panel) the concerned power supplies to the selected devices.

3.4.2 <u>Controlled Parameters</u>

The nine power supplies are controlled by Hybrid Single Transceivers (STH). Twelve bits without sign are used for command and acquisition.

- control voltages 0 -10V 12 bits, no sign - acquisition voltages 0 -10V 12 bits, no sign Actuation bits are as ususal ON STAND-BY OFF Acquisition only

Faults and other status bits are also provided. Fig. 13 gives the position and the meaning of the bits in the different Single Transceiver registers.

During operation with power supplies, the current delivered for a given voltage can change because the value of the charge (R) changes with the temperature.

The acquisition of this current is not possible with the same STH because there is only one analog input. The nine currents are then converted in adequately scaled voltages and are digitized using a Standard MPX + SADC system.

A certain number of temperature measurements are also necessary in the ion source area (high temperature) and in the Faraday Cage area (Low temperature). Six measurement channels have been provided:

- T1 at the Target,
- T2 at ions source,
- T3 Reserved for ion source zone,
- T4 Faraday cage air,
- T5 Faraday cage cooling water,
- T6 Reserved for Faraday cage zone.

The different kind of used thermocouples produces voltages ranging from 0 to 50 mV for the measured temperatures: these values are adequataly amplified (0 - 10V) and are measured using a standard MPX-SADC system.

3.4.3 Hardware Layout

The control modules are grouped in the CAMAC crate no.1 of the CONSOLE 2 as shown in Fig.4.

Three Quad Transceivers control the 9 power supplies. The 16 input channels of the Multiplexer receive the 9 currents and the 6 temperature values. As already mentionned the CAMAC crate is housed inside the Faraday cage: as all the other equipment, it is then at a virtual earth potential of 60 KV. The connection with the CAMAC Loop is realised

3.5 Beam Transport

3.5.1 System Description

by an optical fiber link.

The Ions produced in the source are guided along about 25 m of Vacuum chamber up to the various experiments in the proton hall. During their travel Ions are focused by quadrupoles, steered by dipoles and bended toward user lines by deflectors. All the elements of the beam transport are of the electrostatic type: this allows actions on the Ions independent of their masses.

A) Quadrupoles:

Quadrupoles are grouped in sets of 1 (singlet), 2 (doublet) or 3 (triplet). Each group of quadrupoles, singlets, doublets or triplets, owns a couple of guard rings, one at each side of the group: they compensate for the fringe field of the quadrupoles.

There are nine quadrudoles for the separator.

- 2 singlets,
- 2 doublets,
- 1 triplet.

In the experimental area, there are 28 quadrupoles grouped in 14 doublets.

B) Dipoles (X-Y plates)

These elements permit correction of the Ions trajectory in the horizontal and vertical plane (steering). Each set is composed of a couple of horizontal and a couple of vertical plate to which adequate potential is applied. The feeding for each couple of plates is composed of two power supplies: a fixed one (-1000V) common to all dipoles, and a variable one (from 0 to +2000V) specific to each element.

The combined effect of these two power supplies produces a variable voltage across the plates ranging from -1000V to +1000V.

Three X-plates and three Y-plates are installed in the separator beam path. Another 6 X-plates and 6 Y-plates are installed in the experimental areas. Guard Rings are provided at the two ends of each couple of plates as in A. Guard Rings need a fixed voltage value: this voltage is obtained using adequate attenuators on the common -1000V power supply.

C) Deflectors (Benders)

There are two deflectors in the experimental area: they permit to bend the Ions beam and to bring it to the different users. Each deflector is composed of a couple of curved plates where adequate voltage is applied. Guard Rings are also provided at the two ends of each deflector as in A.

Two power supplies per deflector are installed, one per each plate. The Guard Rings are connected using an attenuator on the common -1000V power supply as for the dipoles.

3.5.2 Controlled parameters

All the power supplies for the beam transport are controlled using Hybrid Single Transceivers (STH).

The command for the actuation (ON/OFF) is <u>manual</u> and individual; only the acquisition of the actuations is possible by computer. The setting control value word is composed of 12 bits without sign. The acquisition word has 12 bits plus the sign bit. The C register of the single transceiver contains a certain number of status bits; the meaning and position of these bits are slightly different for the quadrupoles and for the dipoles. All these informations are summerized in Fig.14.

3.5.3 <u>Hardware Layout</u>

The Quad Transceivers for the beam transport control are housed in two separate CAMAC crates of CONSOLE 3 (See Fig.5).

A) The first CAMAC crate for the separator zone contains:

- two Quad Transceiver (6 STH) for the dipoles,
- three Quad Transceiver (9 STH) for the quadrupoles.

B) The second CAMAC crate for the experimental area contains:

- seven Quad Transceiver (28 STH) for the quadrupoles,
- three Quad Transceiver (12 STH) for the dipoles,
- one Quad Transceiver (2 STH) for the bendings.

3.6 Extraction Electrode Movements

3.6.1 System description

The initial direction of the Ion beam is adjusted using an appropriate extraction electrode system. The extraction tube is mounted on a hydraulic mechanism permitting three degrees of freedom: one longitudinal movement along the Z axe and two tilts around the X and Y axes. The longitudinal movement allows a maximum displacement of 150 mm and requires a resolution of a tenth of mm. The two tilt movements allow a maximum angular rotation of 3 degrees: the corresponding maximum displacement of the edge of the electrode is of 4 mm and the required resolution is of 1/100 of mm.

Three separate D.C. motors provide for the three movements.

3.6.2 <u>Controlled parameters</u>

The three D.C. motors are controlled using three separate Hybrid Single Transceivers (STH).

Twelve bits without sign are used in command and in acquisition.

The produced voltage ranges between 0 and 10 volts:

- zero volt means an initial start position for the longitudinal movement and a maximum negative angle (-3 degrees) for the two tilts.
- 10 volt means a maximum displacement (+150mm) for the longitudinal movement and a maximum angle (+3 degrees) for the two tilts.

The actuations (ON/OFF) exists for all the three motors but they are in common: this means a command on any of the three motors acts on all of them. Some status bits are also provided (see fig. 15): they are the end switches.

<u>Remark</u>: The control value sent to the STH corresponds to the absolute value of the positions required on each one of the three shafts (no incremental mode is used).

WRITE		_	_	READ 48
A				B
A ,	1	<u> </u>	x,	CI OFF
A2	2	1		2 C2
A	3	1	X	
AL	4	1 ⊢	X	
As	5	1 -	- <u>x</u>	
As	6	1 L	X	
47	7]	X 7	C7 N. Warning
A0	8		X	CB Interlock
STROBE ACTUATION	9		5	
٨٩	. 10		XI	C9 I Limit pos.
AD	11		X 1	Clo I Limit neg.
An	12		ХЛ	CII I Limit guard rings
A 12	13			C 12
A 13	ĸ		14	CIS
A 14	15		15	C 14
A 15	16		16	C 15
A 16	17		17	C 16
STROBE TEST	18		18	STROBE STATUS - WORD
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	19		19	MODE REGISTER - C
OV (DIGITAL BOARD)	20		20	ENABLE DELAY - C
-	21		21	
STROBE REFERENCE OUT	22		22	STROBE MEASURE
	23		23	
	24		24	
	ਲ		25	
	26		25	
	27		27	
MEASURE 15V #	21		28	· · · · · · · · · · · · · · · · · · ·
MEASURE ±2.5V #	29		}	OV (ANALOG BOARD)
MEASURE : IV # #			30	
	31		31	
EXT REF + OUT	32		32	
EXT REF - OUT	33		X 33	
INT REF + OUT	34 X		χ 34	
OV (ANILOG BOARD)	35 X		35	COM (OV) EXTERNAL REFERENCE
GATE EXTERNAL REFERENCE INVERTER CONTROL DAC	36			SHUNT POSITION
POLARITY CONTROL OUT	38			POLARITY INVERTER IN
REFERENCE OUT Control	39 X			MEASURE IN + Acquisition
OV (ANALOG BOARD) Voltage	40 X			MEASURE IN - Vollage
UTTAINEDU BUANDI VBITAGE	41		41	
	42		42	
OV (DIGITAL BOARD)	43		43	OV (DIGITAL BOARD)

A 4, 42 43 44 45	1 2 3 4		X I	В
42 43 46	1 2 3 4			
43 44	2 3 4			CI OFF
A.	3		2	C2
	4		χ3	C3 DN
45] —	χ4	C4 OK (no fault)
	5] _	X 5	C5 Up
46	6		χ6	C6 Remote
47	1	⊢-	χ7	C 7 N. Warning
Ag	8		χ 8	CB Interlock
TROBE ACTUATION	9		9	EXT IN COMPARATOR SUPPLY VOLTAGE
19	ю		X 10	C9 Overcurrent
^A p	11	1		Clo System check
4 11	12	Į	}	CII
12	13]		C 12
1 13	<u>k</u>		14	C13
14	15		·	C 14
15	16			C 15
К				C16
	+			STROBE STATUS - WORD
	+	ł		MODE REGISTER - C
VV (DIGITAL BOARD)	+			ENABLE DELAY - C
	+			
STROBE REFERENCE OUT	1			STROBE MEASURE
			·	
				
	+			
				OV (ANALOG BOARD)
	}			
	+		32	
			x 33	DAC IN - REF +
				DAC IN - REF -
	<u> </u>		-35	
SATE EXTERNAL REFERENCE			36	COM (OV) EXTERNAL REFERENCE
NVERTER CONTROL DAC	37		37	SHUNT POSITION
POLARITY CONTROL OUT	38		38	POLARITY INVERTER IN
REFERENCE OUT Control	39 X		X 39	MEASURE IN + Acquisition
DV (ANALOG BOARD) Voltage	40 X			MEASURE IN - Voltage
	41		61	
	62		42	OV (DIGITAL BOARD)
DV (DIGITAL BOARD)	W 2		12	UT TUICITIE DE TEC
	Image: State of the state	10 10 11 11 12 13 13 14 14 15 15 16 14 15 15 16 16 17 17 18 18 17 19 10 14 15 15 16 14 15 15 16 17 18 18 17 19 10 10 16 11 17 11 18 12 17 13 18 14 19 15 16 16 17 17 18 18 17 19 12 11 12 12 12 13 12 14 12 15 16 16 17 17 17	9 10 10 11 12 13 12 13 13 14 14 15 15 16 14 15 15 16 14 15 15 16 16 17 17 18 18 17 19 10 10 17 11 18 12 18 14 15 15 16 16 17 17 18 18 17 19 10 11 11 12 11 13 12 14 15 15 17 16 17 17 18 18 17 17 18 18 17 19 18 10 17 11 18	9 10 X 10 9 10 11 X 10 11 12 13 11 12 13 14 15 13 14 15 15 14 15 15 15 15 16 17 17 17 18 18 18 XI COM OPEN COLLECTOR SUPPLY VOLTAGE 19 19 V (DIGITAL BOARD) 20 20 20 21 22 23 23 22 23 24 24 25 26 26 27 27 27 27 27 21 22 23 23 24 25 26 26 25 26 27 27 27 27 27 27 27 27 27 27 28 29 29 29 29 29 29 29 29 29 29 29 29 29 <th< td=""></th<>

			READ
			В
1	1	XI	CI OFF
2]	2	C2
3] r	X 3	C3 ON
4	1 L	X 4	C4 OK (no fault)
5	1	5	C5
6]	6	CG
1	1	7	1
8]	8	СВ
9	1	9	EXT IN COMPARATOR SUPPLY VOLTAGE
ю	1	10	69
11	1	11	Clo
12	1		CII
B]	13	C 12
4]	14	CIB
15]	15	C 14
16]		C 15
17	1	17	C 16
18	1	18	STROBE STATUS-WORD
19]	19	MODE REGISTER - C
20		20	ENABLE DELAY - C
21		21	
22		22	STROBE MEASURE
23		23	
24		24	
25		25	
26		8	
27		27	
21		28	
29		29	OV (ANALOG BOARD)
30		30	
31		31	
32		32	
33			• •
34 X		χ 34	DAC IN - REF -
35 X		.35	
36			•••••
37			SHUNT POSITION
30			POLARITY INVERTER IN
39	ļ		MEASURE IN + Acauisition
40	ŀ		MEASURE IN - Voltage
I	ł		
41 42		<u> </u>	
	6 7 8 9 10 11 12 13 44 15 16 17 18 19 20 21 22 23 24 25 26 277 24 25 26 277 24 25 30 31 32 33 34 35^{-} 37	6 1 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 27 24 25 26 27 27 24 25 26 27 27 24 25 26 27 27 27 27 27 27 27 27 27 27	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$

3.6.3 Hardware Layout

The only used Quad Transceiver (controlling 3 STH) is housed in the separator zone CAMAC Crate of CONSOLE 3 (Fig.5).

3.7 Analysing Magnets

3.7.1 System Description

Two magnets installed in the Isolde 3 beam line (Fig.1) allow the required separation of the Ion masses.

The selection of the mass is made by the first magnet. The second magnet improves the resolution.

Mass calculation are done using the formula:

 $M = K B^2 / V$ where V is the accelerating voltage.

Measured masses are in the order of hundreds of proton mass and a precision of 0.1 mass is requested (10^{-3}). This means that voltages must be measured with an accuracy of 10^{-3} and magnetic field with an accuracy of 5.10^{-4} .

Magnetic fields is usually determined by measuring the current in the magnet coils.

A more precise measurement is obtained using an Hall effect pick-up. The second method permits the mass determination with the required precision.

The intensity of the ions beam is measured using a Faraday Cup and an high precision ampermeter (10^{-9} A) . The selection of the masses (current setting in the analysing magnets) is done by computer using the control console in the control room. The user can also specify mass locally by sending appropriate information to the computer (see below).

3.7.2 Controlled Parameters

The analysing magnets are controlled using a QT and two digital ST. The command word is 16 bits without sign. Acquisition word is 15 bits plus sign bit. Actuations are standard in command and acquisition. Several status information are also provided as indicated in Fig.16.

Ion current is measured using an Keithly picoampermeter connected to CAMAC via a GPIB Mod. KINETICS 2232 standard interface module. The IN/OUT of the Faraday cup is done via an I/O register (see also 3.8.2) The connection with the Hall plate device Teslameter is done by means of RS 232 interface mod.3340.

To permit the user to select masses an I/O register is installed in the Camac crate. Masses are specified by sending to the input register (16 bits) the BCD code of the selected value. For example

WRITE					READ	52
A					В	
A, OFT	*	1χ	<u> </u>	X /	CIOFF	
A2		2	1		C2	
A, ON	*	3 X	1	X 3	C3 ON	<u> </u>
A4		4	1	4		
As	ľ	5	1	5	65	
As	ľ	6	1	6	4	
A7	ľ	1	1	7		
A	ļ.	8	1		CB	
STROBE ACTUATION		9	1		EXT IN COMPARATOR SUPPLY YOLTAGE	
٨,		ю	1	10	69	
Ap	Ţ.	11	1	"	C 10	
A 11	Ţ,	12	1			
A 12	,	13	1		C 12	
A 13	Į.	4	1	16	CIB	
A 14	l l	5	1	15	C 14	
A 15	Ţ,	6	1		C 15	
AK	Ī	1	1		C 16	
STROBE TEST	i	8	1	18	STROBE STATUS-WORD	
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE	1	9		19	MODE REGISTER - C	
OV (DIGITAL BOARD)	2	0	1	20	ENABLE DELAY - C	
	2	27	1	21		
STROBE REFERENCE OUT	2	2	1	22	STROBE MEASURE	
	2	3	1	23		
	2	4	1	24		
	2	5	1	25		
	2	6	1	25		
	2	7	1	27		
MEASURE 15V #	2	1		28		
MEASURE ±2.5V #	2	9		29	OV (ANALOG BOARD)	
MEASURE 1 IV # #	34	0		30		
	3	1		31		
EXT REF + OUT	32	2 -		32		
EXT REF - OUT	3	3			DAC IN - KEF +	
INT REF + OUT	34	4 X	/ /	χ 34	DAC IN - REF -	
OV (ANALOG BOARD)	3	sχ		·35		
GATE EXTERNAL REFERENCE	38	5		36	COM (OV) EXTERNAL REFERENCE	
INVERIER CONTROL DAC	37	/		37	SHUNT POSITION	
POLARITY CONTROL OUT	35				POLARITY INVERTER IN	
REFERENCE OUT Control		9 X	[MEASURE IN + Acquisitio	50
OV (ANALOG BOARD) Voltage		<u>, X</u>		X 10	MEASURE IN - Voltage	
	41	1		41		
OV (DIGITAL BOARD)	62			42	OV (DIGITAL BOARD)	
	4	,		43		
Console: 3						
	~ 1	_ 1 .	1		and the last of the	
Loop: 1 Crate: 1	510	⊃†∶	17	C	-	
					2 Angular Y - AX	15
* For longitudinal moveme	ent o	nly			3 Longitudinal Z-	AX (!
Standard Interface						fi
The TRANSCENER HYSRID VERS. 80302 CC				-	le 3 controls electrode movements	

WRITE		READ 53	
A		В	
REG AI OFF	1 X	X 1 REG CI OFF	
A2 Standby	2 X	X 2 C2 Standby	
A3 ON	3 X	X 3 C3 ON	
A4 Reset	4 χ	X 4 C4 OK (no fault)	
A5	5	x 5 C5 Up	
A6	6	X 6 C6 Remote	
A7	7	x 7 C7 N. Warning	
A8	0	X 8 C8 Interlock	
STROBE LS BYTE REGA	9	9 EXT IN COMPARATOR SUPPLY VOLTAGE REG C	
A9	ρ	X 10 C9 O. current rect.	
AD	π	X 11 CD W.F. rect.	
A11	12	X 12 (11 Temp. rect.	
A 12	13	X 13 C12 Phase	
A13	14 .	X 14 CB Earth fault	
A 14	15	X 15 CH O. current magnet	
A15	16	X 16 CIS Doors	
A16	17	X 17 Cl6 W.F magnet	
STROBE MS BYTE REG A	18	18 STROBE REG C	
EXT CON OPEN COLLECTOR SUPPLY VOLTAGE REG A	19	19 MODE REGISTER C	
OV (DIGITAL BOARD)	20	20 ENABLE DEĽAY · C	
	21	21	
STROBE REG B	22	22 STROBE REG D	
REG BI LSB	23 X	Y 23 REG DI LSB	
<i>B2</i>	24 X	<u>X 24</u> D2	
<i>B</i> 3	25 X	X 25 03	
84	26 X	X 26 D4	
85	27 X	X 27 05	
86	28 X	X 28 D6 X 29 D7	
87 88	29 X		
89 16 BIT control value	30 X 31 X	X 30 08 15 BIT acquisition value	
89 810	31 X 32 X	X 32 010	
811	33 X	X 33 D11	
812	34 X	X 34 012	
B13	35 X	X 35 D13	
B 14	36 X	X 36 D14	
815	37 X	X 37 D15	
BIG MSB	38 X	X 38 016 Sign (1= minus)	
EXT COM OPEN COLLECTOR SUPPLY VOLTAGE REG B	39	39 EXT IN COMPARATOR SUPPLY VOLTAGE REG D	
	40	40 MODE REGISTER D	
	41	41 ENABLE DELAY-D	
OV (DIGITAL BOARD)	42	42 OV (DIGITAL BOARD)	
OV (D.G.TAL BUARD)	43	43 UV (DIGITAL BOARD)	
onsole:3			
oop:1 Crate:1	Slot: 2	Channel:1 (90° Magnet) 2 (60° Magnet)	
Standard Interface			
TRANSCENER DIGITAL VERS 80303 CC Power supplies for			

to obtain a mass of 144,5 the user has to send the value 1445 coded in BCD. The computer will read periodically the input register and will adjust the current in the magnet appropriately.

3.7.3 Hardware Layout

The Quad Transceiver, the GPIB interface and the RS 232 module are installed in the crate no.1 of the Loop no.3 as explained in Fig.5. The I/O register is installed in the crate no.2 of the CONSOLE 3.

3.8 BEAM DIAGNOSTIC

Four types of devices are foreseen for beam disgnostics:

- 1) SLITS
- 2) FARADAY CUPS 3) WIRE GRIDS 4) WIRE SCANNERS

In the present layout only the control of the first two devices (slits and Faraday cups) are described. The other two devices are not controlled by computer for the time being.

3.8.1 SLITS

This device permits to reduce the transversal dimensions of the ion beam. It is composed of plates that are introduced in a plane perpendicular to the beam. In general each group of SLIT is composed of 2 horizontal and 2 vertical plates that can be moved separately.

There are two types of SLITS:

- fixed position SLITS that can be introduced into the beam only at a fixed position (holes in the plate).
- proportional SLITS that can be moved into the beam at any variable position.
- A) Fixed position SLITS

There is only one set of these SLITS. Only three simple commands are foreseen: - IN, - OUT, - NEUTRAL, corresponding to an intermediate position.

Control is done using an I/O register type BORER 1031: acquisition of the status is also provided using the same module. The first three bits are used with the meaning:

- 001 IN - 010 OUT - 100 NEUTRAL.

The I/O register is housed in Crate no.3 of CONSOLE 1 as shown in fig.3. See also fig.17.

B) **Proportional SLITS**

There are two sets of this type of SLITS. Each set is composed of a couple of horizontal and a couple of vertical plates. Each plate can be moved individually. Control and acquisition are done using Hybrid Single Transceivers (HST): twelve bits without sign corresponds to a maximum voltage of 10V sent to the motor. Each plate has assigned an independent motor and then a HST: in total there are 8 HST connected to 2 Quad Transceivers (QT). No ON/OFF or other status bits are foreseen. The two QT are housed in Crate no.3 of CONSOLE 1 as shown in fig.3. See also fig.17.

3.8.2 Faraday Cups

This device permits an absolute reading of the beam current. The collected charge is measured using a sensitive electrometer (Keithly). There are several F.C. in ISOLDE 3 experiment, some in the separator zone, other in the experiment area.

In the present layout we foresee the control of 8 F.C., but extensions are straightforward.

Only one F.C. can be controlled at a time.

The control realizes the following functions: - putting a F.C. IN or OUT, - connecting the selected F.C. to the electrometer (SCANNER), - reading the electrometer.

The first function is performed using an I/O register type BORER 1031. Two exclusive bits are allocated per F.C. giving a total of 8 F.C. connected to the register. Acquisition of the IN/OUT condition is also obtained in the same register with the same bit pattern. The other two functions are realized using a GPIB interface type KINETICS 2232. The I/O register and the GPIB interface are housed in the Crate 3 of the CONSOLE 1 as shown in fig.3. See also fig.18.

<u>Remark</u>: one of the Faraday Cups exists in the system (see 3.7.1) controlled in a similar way but in CONSOLE 3: this is used in connection with the control of the analysing magnet to measure the total ion current. For this reason this F.C. must be controlled by the same console as for the Magnet.

3.9 TAPE TRANSPORT

This device permits to measure the activity of ion samples collected on a moving Tape.

	WRITE				READ	56
	A				В	
		1		,	СІ	
A	2	2		2	C 2	
A	ز	3	1	,	I CB	
	4	4	1		C4	
	5	5	1	5	C5	
A		6	-1	6		
		17	1		C7	
		8	-	<u> </u>	Св	
	TROBE ACTUATION		-		EXT IN COMPARATOR SUPPLY VOLTAG	6
		10	-	· · · · ·	C9	<u>σ</u>
1 1	۲ ۵	}	-	}		
		11 12	-		Clo	
	11		-{			
1 1	12	13	-		C 12	
A		<u>к</u>	-		CIB	
		15	4	\rightarrow	C 14	
A		16	_	· · · · · · · · · · · · · · · · · · ·	C 15	
		17	_	·	C16	
	TROBE TEST	18	1		STROBE STATUS-WORD	
	IT COM OPEN COLLECTOR SUPPLY VOLTAGE	19	1	19	MODE REGISTER - C	
01	(QIGITAL BOARD)	20	1	20	ENABLE DELAY - C	
	·	21	_	21		
SI	RORE REFERENCE OUT	22	1	22	STROBE MEASURE	
		23		23		
		24		26		
		ಜ		25		
		26]	8		
		27]	27		ĺ
M	EASURE 15V #	28]	28		
M	EASURE 12.5V #	29]	29	OV (ANALOG BOARD)	
м	EASURE 1 IV # #	30]	30		
		31]	31		
EX	T REF + OUT	32 .		32		
EX	T REF - OUT	33		X 33	DAC IN - REF +	
IN	T REF + OUT	34 X	$V \downarrow$	X 34	DAC IN-REF -	
01	(ANALOG BOARD)	35 X	\vee	ĸ		
GA	TE EXTERNAL REFERENCE	35		35	COM (OV) EXTERNAL REFERENCE	
1/1/1	ERIER CONTROL DAC	37			SHUNT POSITION	
PO	LARITY CONTROL OUT	30		38	POLARITY INVERTER IN	
RE	FERENCE OUT Control	39 X		X 33	MEASURE IN + Acquisit	ion
ov	(ANALOG BOARD) Voltage	40 X			MEASURE IN - Vollage	
		41		41		
	(DIGITAL BOARD)	42	Ì	62	OV (DIGITAL BOARD)	
		43	ľ	43	OV [DIGITAL BOARD]	
1	sole: 1 p: 1 Crate: 3	Slot:	5+6	C	HANNEL 1 : Left Pla 2 : Right Pla 3 : Top Plat 4 : Bottom f	te e
	~				7 · 50110m ·	
TITLE	Standard Interloce		1.	II	e 3 controls	fig
11110	Standard Internace		1.4	SOIO	e o controis	1

IN BITS	OUT BITS		
1	1	ID. (UP 01	I N
2	2	ID. CUP 01	OUT
3	3	ID. CUP 02	IN
4	ч	ID. CUP 02	OUT
5	5	ID.CUP 03	IN
6	6	ED.CUP03	OUT
7	7	ID. CUP 04	IN
8	8	ID. CUP 04	OUT
٩	9	ID. CUPOS	IN
10	10	ID. CUP 05	OUT
ADDRESS :	(ONSOLE 1	L=1 (=3	N = 11

FARADAY CUPS IN/OUT HOVE MENTS SEPARATOR ZONE

fig. 18

The presented control layout is based on a first estimation of the functions needed by the measurement: it is possible that the actual implementation requires some modifications.

The following modules are used:

- five General Purpose Preset Counters (GPPC) generate 10 timing Triggers to start and to gate the different operations,
- one clock module provides the pulse trains to feed the GPPC's,
- one double UP/DOWN Counter provides counting facilities up to 2³² - 1 counts for a single measurement.

These modules are housed in Crate no.2 of CONSOLE 1 as shown in fig. 3.

4- SOFTWARE LAYOUT

As already mentionned in each console there will be only a main program (TRUNK), written in Nodal, taking into account of both the global applications structure and the execution of each application itself.

Applications are organized in a hierarchical tree structure: subsequent pages on the touch screen permits the operation to select a program and to execute the appropriate action.

Separate hardware buttons permit at any moment to come back to the previous page or to the main trunk. The main program has to interrogate periodically (LOOP) many interactive devices and at the same time has to generate display, has to control parameters etc...; as a consequence the response time cannot be very short.

Nevertheless an adequate choice of software techniques permits to keep this value inside acceptable limits.

4.1 Equipment Modules (EM)

Each hardware system has a specific control protocol: this depends on the intrinsic characteristics of the system and on the standard CAMAC interface module connected to it.

The equipment module is a software package that absorbs all the intricacies of the different systems and presents to the application program a standard calling protocol.

For example, if one wants to set a control value of 10 Amps on the power supply number 4; and a setting value of 1000 in the preset counter number 5, we write in NODAL:

> SET POW(4,"CCV")=10 for the power supply SET TIM(5,"CCV")=1000 for the timing

For this example the programmer does not need to know the CAMAC address of the module: this is already coded in the first parameter called the equipment number.

He does neither have to know the CAMAC sequence to send the set value: this is imbedded in the codeof the second parameter (CCV: Current Control Value) called the property.

The use of equipment modules in general:

- eases dramatically the writing of applications,
- avoids the code duplication,
- once it is written and well tested, the software errors in CAMAC addressing are impossible,
- greatly facilitates the maintenance and testing; a short test program can be written in a few minutes by non-specialists.

Equipment modules exist already in the PS Control system but they are written in a compiled language and their execution is very fast.

For the ISOLDE 3 Control System, we use, for the first time, a stripped-down version of equipment module written in Nodal.

We have made a version of EM that, without loosing the essential in code capability and error treatment, is executed in about 90ms.

This value is acceptable in most of applications. Up to now 5 equipment modules have been identified:

- POW for Power Supplies - IVV for Vacuum Valves
- IVP for Vacuum Pumps
- TIM for Preset counters
- ADC Con Country ADC
- SADC for Scanning ADC

See ANNEXE 2 for a detailed description of each EM.

4.2 Equipment Survey

A Survey system with Display will exist in each one of the three consoles. Due to the previously mentionned limitations, the survey program will run only when no other applications are executed on a console. This survey program will be started automatically when the operator pushes the option "TRUNK" on the console. The original "TRUNK" program has been modified: it now interrogates, as usual, the touch screen buttons <u>and</u> executes the Survey in a Loop. The Survey will periodically scan the parameters belonging to the concerned CAMAC Loop and will display errors and inconsistencies between command set values and acquisitions. The list of parameters and the format of the display messages will be discussed with the concerned

4.3 Application Programs

specialists.

This is a first and incomplete description of the application programs. In the definitive version of the present note, this part will be replaced by an appendix containing all the required details. For this reason the figures are just examples.

4.3.1 Programs of CONSOLE 1

CONSOLE 1 concerns the controls of the Vacuum system, of the tape transport, and the existing beam diagnostics. The first page (Fig.19) contains the selection between the three systems. Vacuum has been separated in two zones: separator zone and experimental areas. The corresponding programs have identical structure.

PUMPS VALVES The corresponding synoptic is in Fig.20. CONTROL

This is a repetitive program (LOOP): this means that all indications contained in the display are refreshed periodically; {the period depends on the software and on the actions required). The colours convention is the following: - PUMPS = 0FFRED = ON GREEN YELLOW = Undefined - VALVES RED = CLOSED GREEN = OPEN YELLOW = Undefined - BEAM Line two pieces of Beam Line immediately preceding and The following a pump will be: GREEN indicating a Vacuum OK RED indication Bad Vacuum.

If a pump or a valve are in LOCAL Control, this message will be displayed near the concerned element. Interactions are possible using the Track-Ball. Each control is interpreted as a request to change the status of the element (FLIP-FLOP): if green, it becames red and viceversa. The element that one can control are: the pumps, the sectors and the valves.

If the element is in an undefined status (yellow) the control action is interpreted, for security reasons, as a request to go into OFF status for a pump and into CLOSED status for a valve.

HISTOGRAM

This is a ONE-SHOT program (Non-repetitive)

The pressure values at the calling time are displayed on a logarithmic scale as in Fig.21. For each sector the penning value is in green and the Pirani reading is in yellow. The pressure values are also displayed in digital form.

HISTORY

It is proposed to read periodically (Half hourly ?) all the pressure values and to store them in the memory. The values corresponding to the last, say, ten hours can subsequently be displayed for selected sectors (Fig.21).

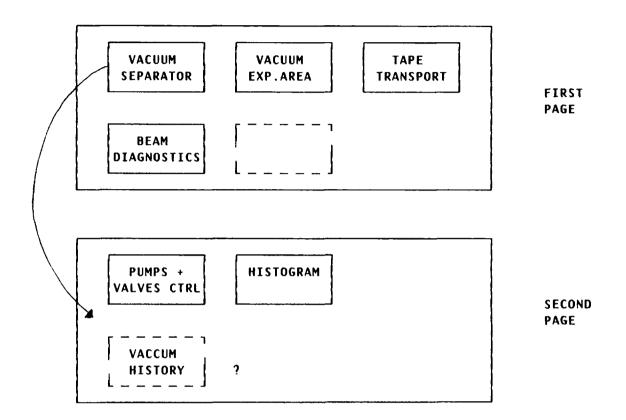
TAPE TRANSPORT

This program needs more detailed specifications.

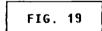
BEAM DIAGNOSTICS

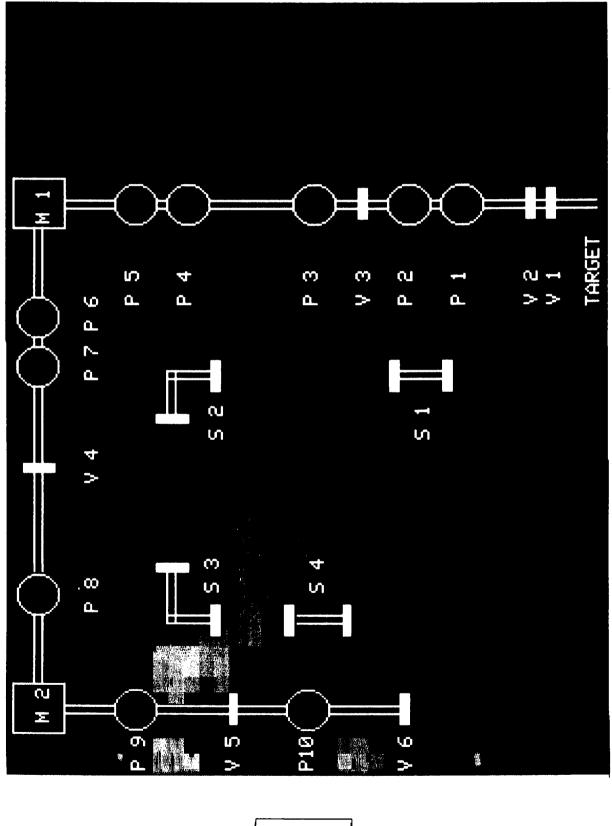
The programs for the SLITS and for the FARADAY CUPS have not yet been specified.

CONSOLE 1 TREE



By pushing the "TRUNK" button, the SURVEY will be activated.





63

FIG. 20

29 MAY 86 13:36:22 PIRANI PRESSURE PENNING PRESSURE

 IB
 -3 - 1
 FENNING PRESSURE

 10
 -3 - 1
 -3 - 1

 10
 -4 - 2
 -4 - 2

 10
 -5 - 3
 -1

 10
 -5 - 3
 -1

 10
 -5 - 3
 -1

 10
 -7 - 5
 -1

 10
 -7 - 5
 10

 10
 -7 - 5
 10

 VACUUM HISTOGRAM

FIG. 21

VACUUM HISTOGRAM (SEPARATOR)

PUMP NUMB

20

15

4.3.2 Programs for CONSOLE 2

In LOOP 2 are grouped parameters of the accelerating devices (60 KV) and of the Ion source.

The first page on the touch screen permits a selection as shown in Fig.22.

60 KV ACCEL. This is a repetitive program.

The second page on the touch screen permits all actuations on the 60 KV power supply.

The first KNOB is connected to the Reference Control Value and two sensitivities are allowed: a coarse for fast reaching of the setting value and a fine one for fine adjustement. On the Colour TV are displayed and continuously refreshed all the parameters and the various interlocks of the 60 KV system (Fig.22).

ISOL. TRANSFO This is a repetitive program.

By depressing this button a second page is generated on the touch screen in which only buttom ON, OFF and RESET are present. A serie of interlock and status conditions are repetitively displayed on the colour TV.

ION SOURCE + TARGET

This is a repetitive program.

Nine separate power supplies are controled in this system (See Hardware Layout).

Five different configurations of these power supplies are used following the experiment requirements.

Each configuration uses only a certain number of power supplies selected between the nine existing ones.

The five configurations are:

- PLASMA Ionisation source with the line cathode,
- PLASMA Ionisation source with forced electron emission,
- Surface Ionisation source with ohmic heating (1),
- Surface Ionisation source with ohmic heating (2),

- negative Surface Ionisation source with ohmic heating.

Each configuration has a separate control program with related synoptics.

The system is easily extendable to other configurations. By depressing the program buttom a second page (see Fig. 23) is generated with the

choice between the five configurations. By selecting a configuration a third page is generated on the touch screen giving access to the final program. No individual ON-OFF are foreseen because setting-up and closing beam programs are foreseen.

GENERAL CONTROL

This is a repetitive program.

The concerned synoptic is generated.

Using the track-ball the selected power supply is connected to a knob. At the start of the program, if a power supply is found to be OFF, its control value is set automatically to zero. In this case a setting-up procedure is necessary.

<u>Remark</u>: An important number of status and interlock messages need to be displayed. If this number will result too big for the colour TV, a second B/W display should be added.

CLOSING BEAM

This is a one-shot program.

When the experiment is terminated, this program will permit to switch off the power supplies and to save the last setting values in a table for subsequent use.

The switching off requires probably a special programmed procedure that must be specified by specialists.

SETTING UP

This is a one-shot program.

The program will switch on only the concerned power supply and will put the required settings following a procedure specified by specialists.

OUT GASING TARGET Pro

Program not yet specified.

4.3.3 Programs of CONSOLE 3

In LOOP 3 are grouped the controls of the analysing magnets, beam transport elements and extraction electrode movement.

In the first page (see Fig.24) we find a first choice between separator zone and experimental zone. These programs for the two branches of the tree are similar but, of course, in the second group there are no programs for the mass meter.

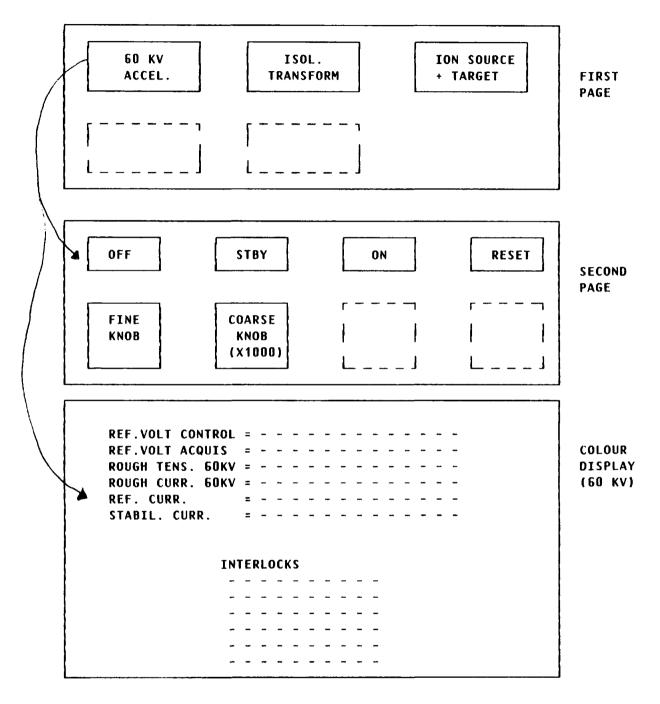


FIG. 22

INDIVIDUAL CONTROL

This is a repetitive program (Fig.24).

Either knob can be connected to any of the presented elements. Using the track ball one first select a parameter and one connect it to a knob by depressing the valid button near the knob.

In this way any two selected parameters can be controled at the same time. This program is inteded only for adjustement of the different power supplies: no ON/OFF actuations are provided neither the treatment of the various status and interlocks. For this other specified programs are foreseen (See SETTING and STATUS). The "usual" operating procedure is to run first the SETTING program and to adjust after with the individual control.

SETTING

SAVE

This is a one-shot program.

This program switches on all power supplies (where this command exists) and sets them to the predefined control values. The setting procedure are defined by specialists.

This is a one-shot program.

The actual setting values are stored in a specific file into the memory module. The saved value can be, e.g., used subsequently by the setting program.

If required this program could be improved by providing several saving files (each one labeled with a name and a date), to cover different experiments or operational situations (ARCHIVES).

STATUS + DIAGNOSTIC This

IC This is a repetitive program.

By depressing this button a second page is displayed on the touch screen permitting actuations (Fig.25). At the same time a display is generated containing all status information and actuations.

The power supplies are grouped in sets of 8. To pass from a set to another one pushes the "NEXT" button. The track ball permits to select a power supply on the display: The touch screen interactions are then valid for the selected power supply.

This program is intended expecially for the hardware specialist: the presentation will depend on his specifications.

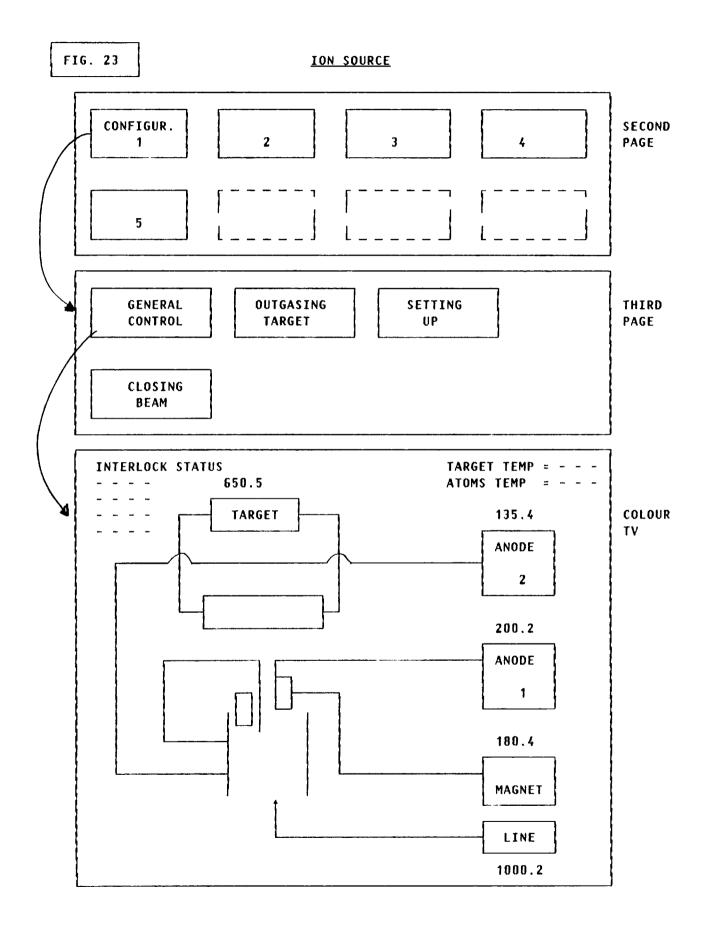


Fig. 23.1

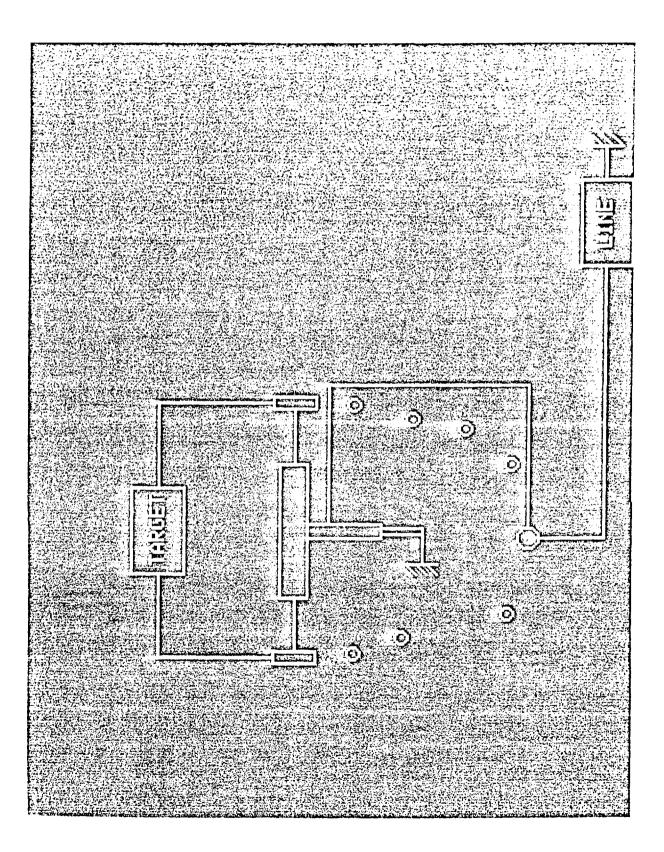


Fig. 23.2

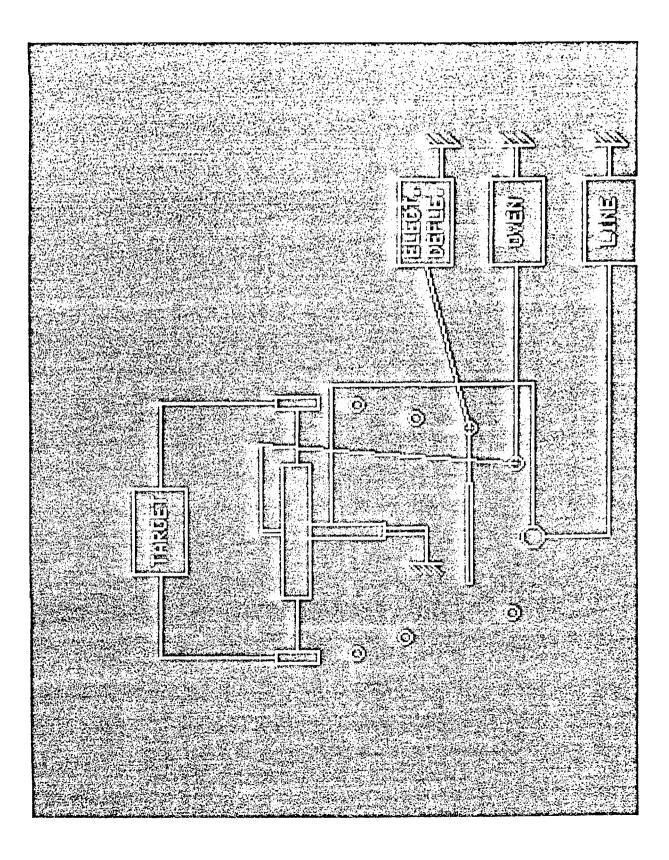
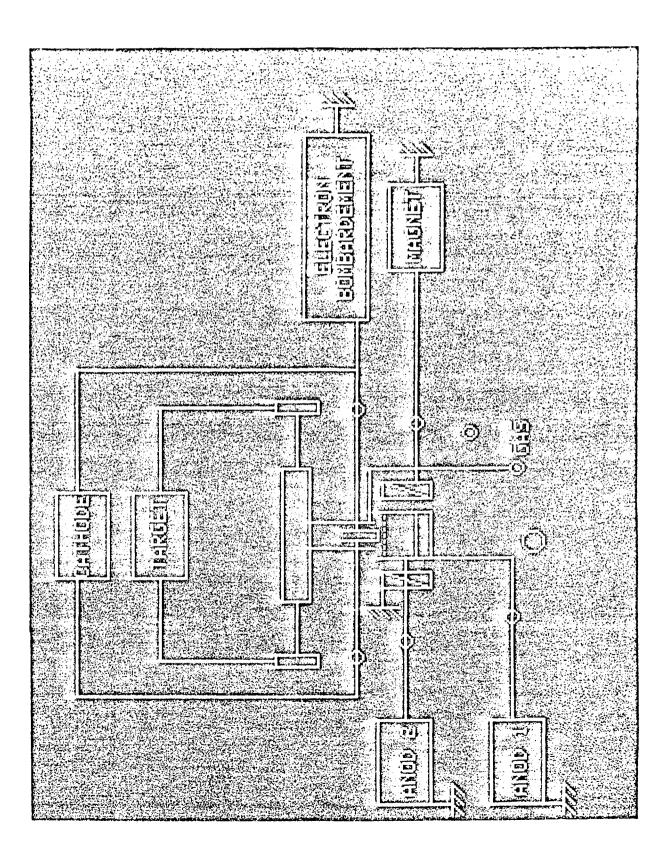
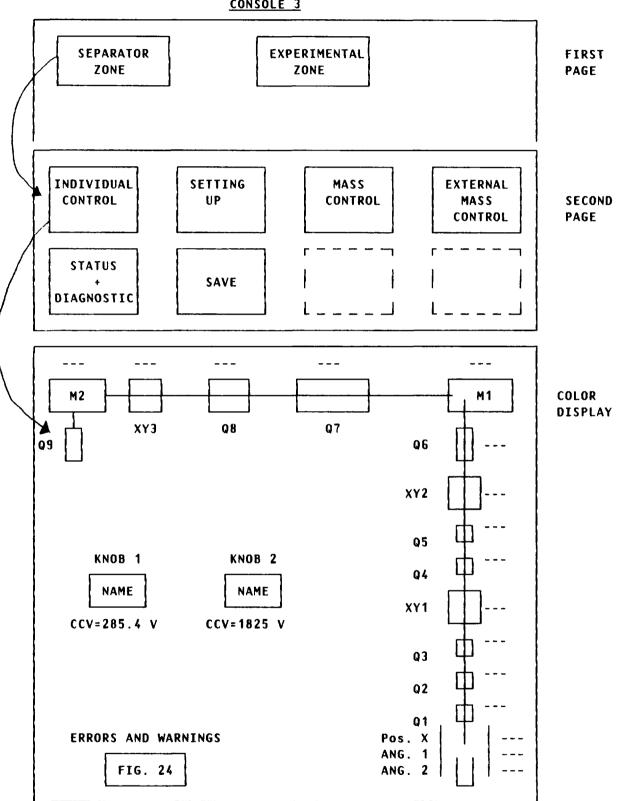
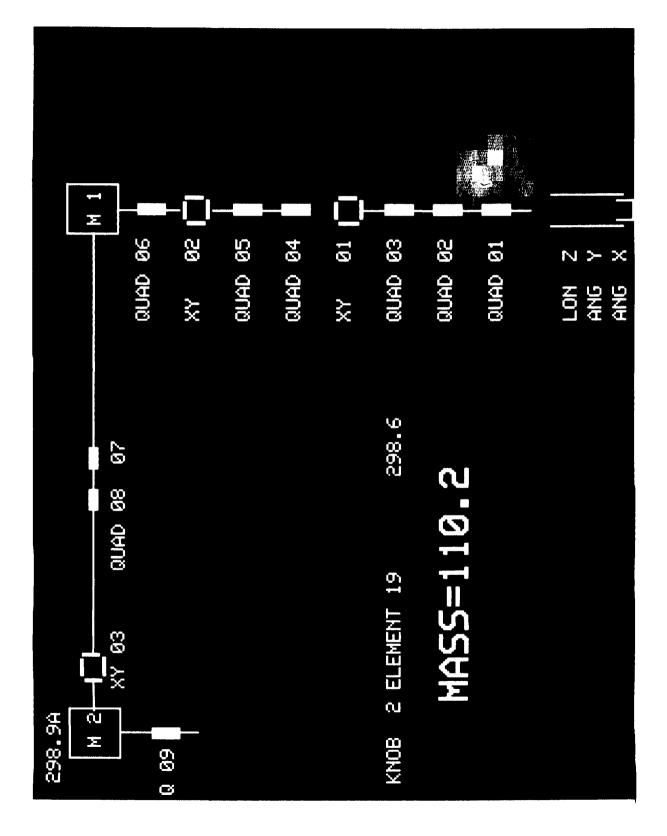


Fig. 23.3





CONSOLE 3



MASS CONTROL

This is a repetitive program.

The program will command the first analysing magnet current and will read and display the mass values deduced from field measurements or from direct magnet current.

This program requires a calibration facility (See 3.7.1).

EXTERNAL MASS CONTROL

OL This is a repetitive program.

This program is started, as the usual, by depressing the corresponding button on the touch screen.

Initials conditions, as the mass scan range, and other useful informations will be specified interactivelly from the main console. Once the program initiated, the user has the possibility to set locally the value of the selected mass. To do this he sends a 16 bit, BCD coded, word to an I/O register in the Camac crate (See hardware part).

The program will read continously and will set consequently the magnet current

The exact value of the selected mass will be also continously displayed (Hall plate).

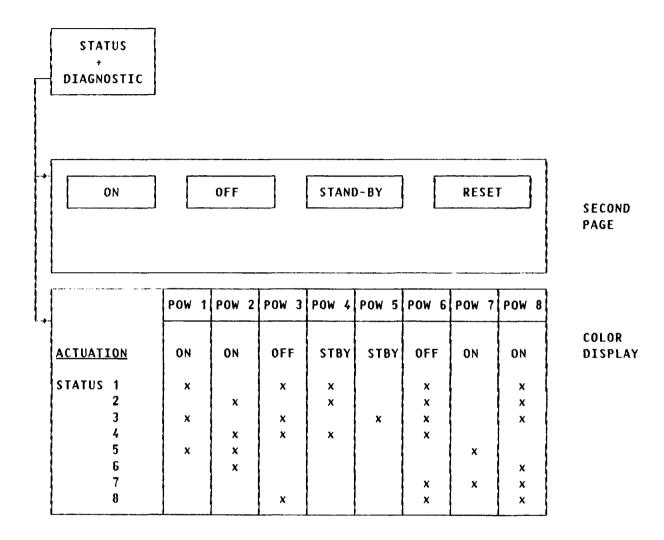
The user has also the possibility to locally stop the program: to do this, he will send a BCD code corresponding to the number 9999. The program will then return to the Trunk and activate the ALARM.

LOCAL DISPLAY AND SURVEY

The Survey program in CONSOLE 3 will display, as for the other loops, all useful information on the status of various equipments. It will also contain a continously refreshed information on the selected mass.

A B & W television screen will repeat in the experimental areas the Survey display.

CONSOLE 3



STATUS PROGRAM

FIG. 25

ANNEXE 1

ISOLDE 3 Control Room

1) RACKS

An assembly of 5 Wilsher racks is installed on the left side of the control room. They are cooled by a GENERAL ELECTRIC air conditionner. For the time being only 3 racks are filled with computer equipment, leaving 3 racks in reserve:

- rack 1 (general service rack):
 - Floppy disc
 - type Scientific Microsystem FT 0222 I-ER
 - double hight EURO crate containing the electronic equipment for the keyboards.
 - switch unit for the floppy
 - switch unit for the printer
 - switch unit for the hard copy unit
 - patch panel for video signals, enables the temporary or permanent transmission of video signals from the control room to the Proton Hall.
- rack 2 (mother crates):
 - system SC (or reserve)
 system 1, ISOLDE 3

rack 3 (mother crates):

- system 2, ISOLDE 3 - system 3, ISOLDE 3

2- Printer / Hard Copy Unit

- There will be one printer (TEXAS INSTRUMENTS OMNI 800), which has to be shared by the 3 ISOLDE 3 systems. The corresponding switching unit is installed in rack 1.
- A black and white hard copy unit (Tektronix 4632) has also to be shared by the 3 ISOLDE 3 systems.

A <u>manual</u> switching unit is foreseen in rack 1. This unit will allow to connect any of the DICO/CODIME signals to the hard copy unit that means all video signals which belong to the main colour displays, the touch screen and possible additional display screens.

3- Mother Crates

The mother crate, setting in rack 2 and rack 3 are identically equipped. For details see drawning 1.

4- <u>Control Desk</u>

There will be a 6 bay control desk. Mechanically it is identical with the desks which are used in the PS MCR with exeption that:

- it is split in the middle (thus allowing to install, if necessary, a 7 th bay)
- the depth had to be reduced due to the limitted space in the ISOLDE 3 control room; consequently it will not be possible to install crates on the rack side of the bays.

The minimum outfit per system of control desk equipment will be:

- a keyboard, type EURO key

- a double unit 9" b/w monitor unit
- 1 tracker ball
- 2 knob encoders
- 1 colour display, type BARCO CDCT 5151

There will be space to install, if necessary, further 19" rack mountable equipment. Total available space per system (in addition to the space already filled by the above mentionned equipment):

15 + 5 units

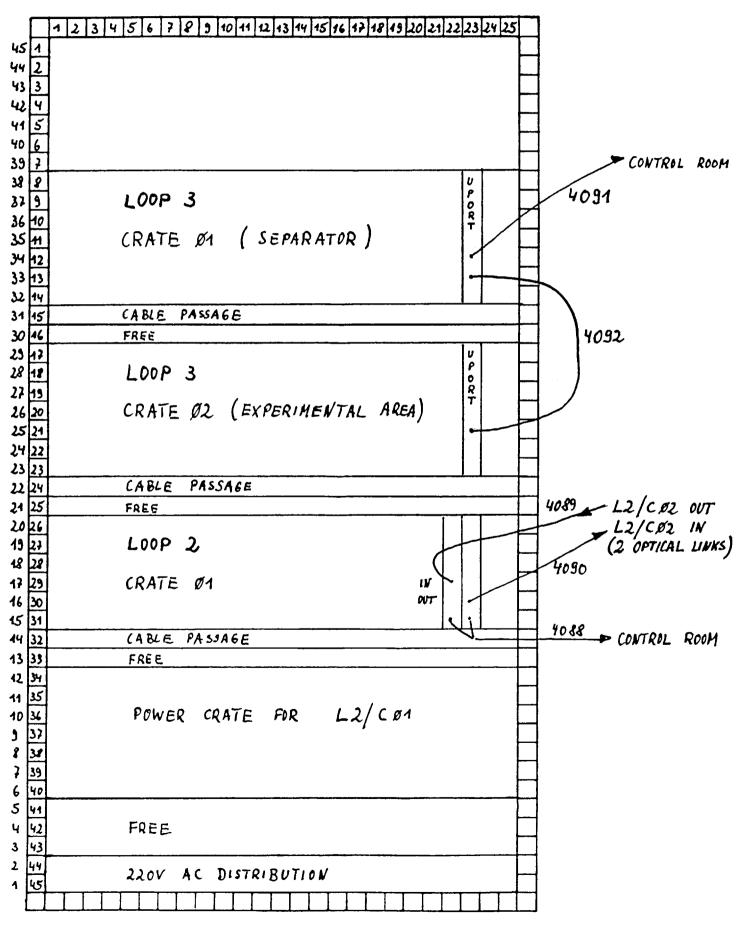
The 6 bays are attributed to the 3 systems in the following way:

<u>bay</u> 1 and 2	<u>CONSOLE</u> 2 Transformer 60 KV Ion Source + Target Supplies
<u>bay</u> 3 and 4	<u>CONSOLE</u> 1 Vacuum Tape Transport Beam Diagnostics
<u>bay</u> 5 and 6	<u>CONSOLE</u> 3 Analysing Magnets Beam Transport Elements Extraction Electrode

See also the annexed drawing.

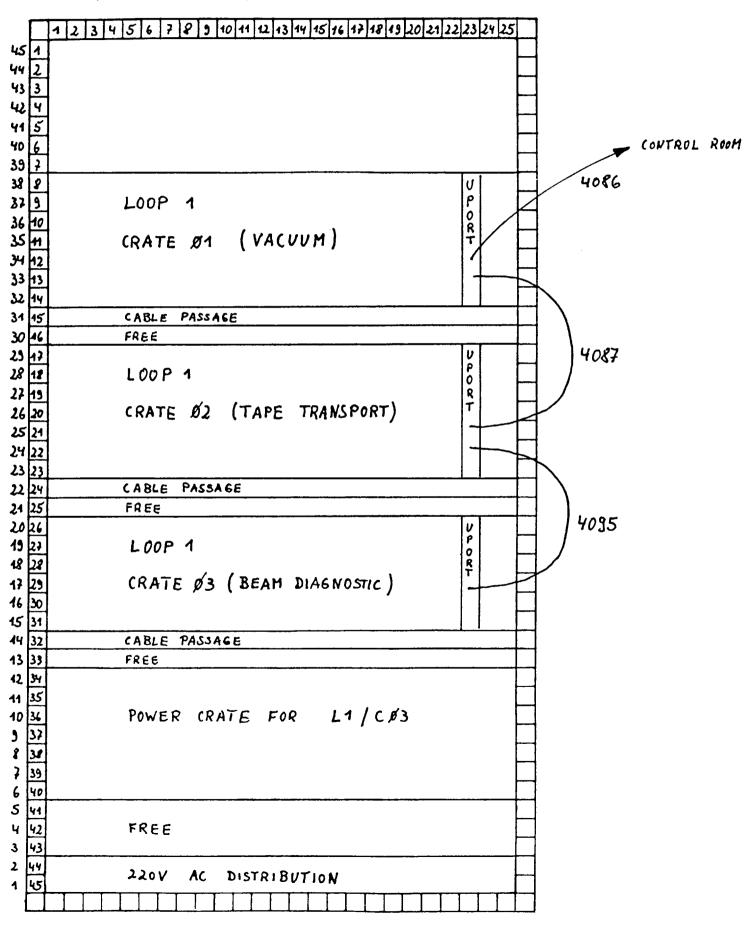
RACKS FOR COMPUTER EQUIPMENT 8.04.86

LUCATION : PROTON HALL RACK NUMBER : 02



RACKS FOR COMPUTER EQUIPMENT 8.04.86

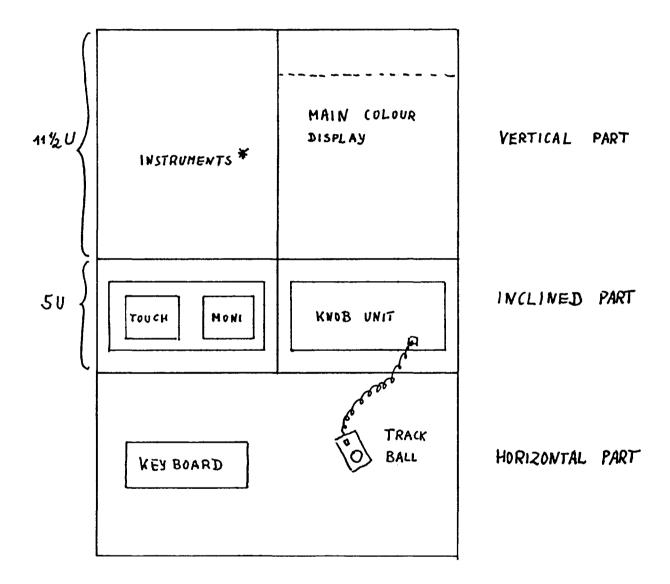
LOCATION : PROTON HALL RACK NUMBER : Ø1



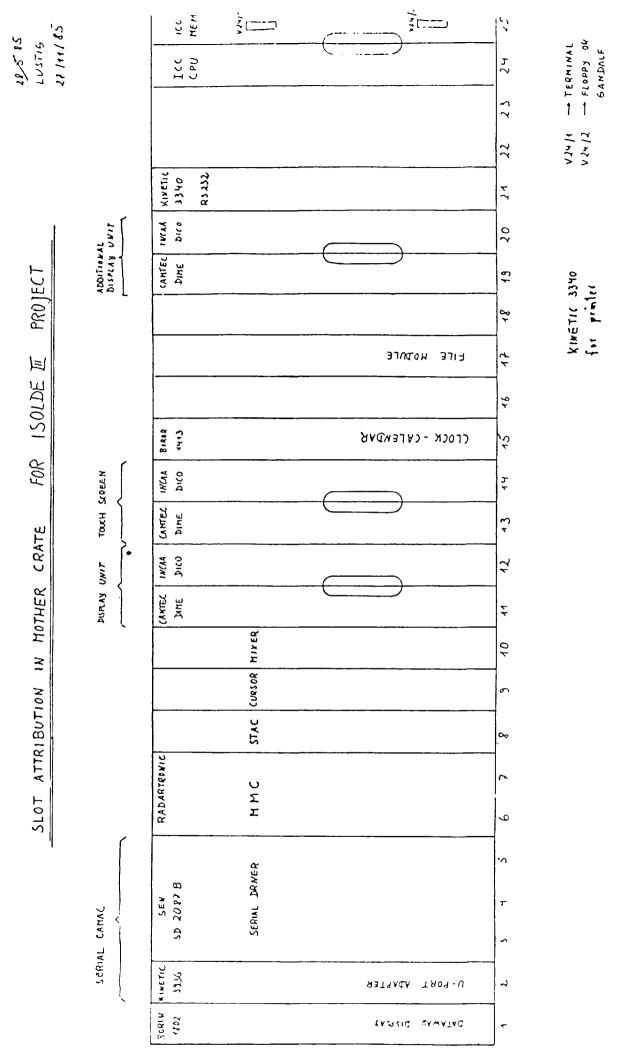
GENERAL LAYOUT OF CONTROL DESK

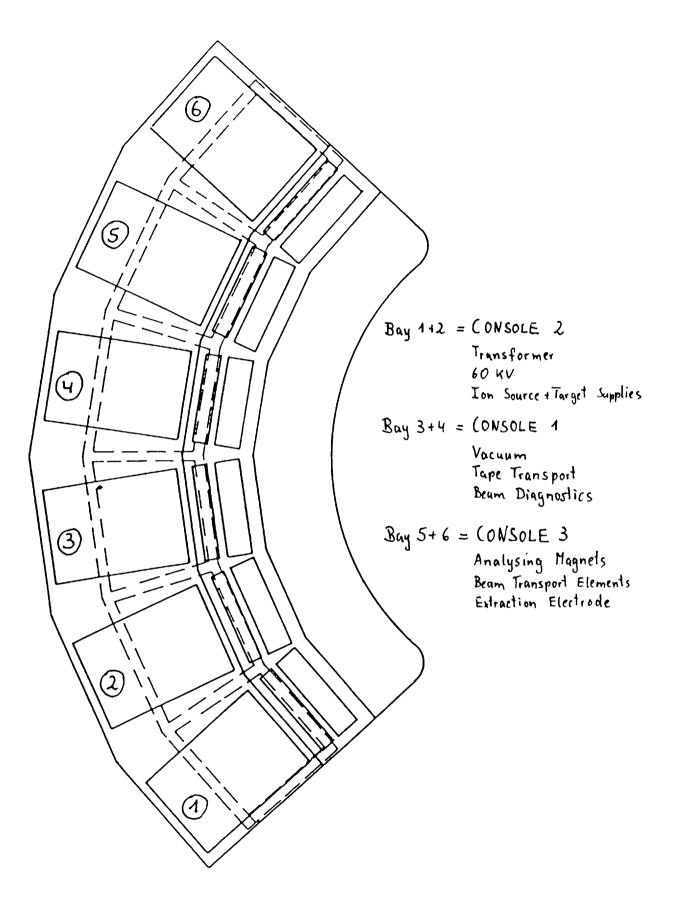
ISOLDE 3 CONTROL ROOM

(identical for the 3 loops)

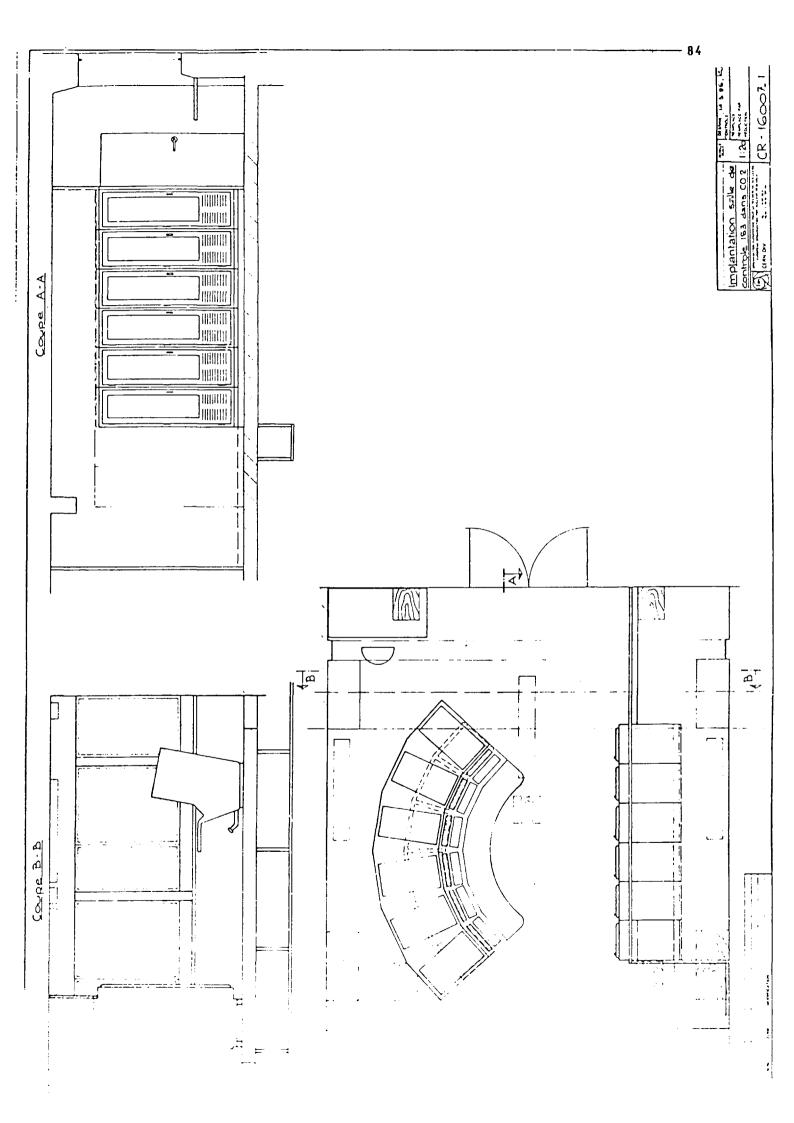


* FREE SPACE FOR OSCILLOS(OPS, DVMs, COUNTERS OR OTHER SPECIAL MEASURING INSTRUMENTS





ISOLDE 3 (ONTROL DESK



ANNEXE 2

1. USE OF THE EM

The E.M. are 2 parameters <u>defined functions</u> written in NODAL and stored in <u>defined function area</u>. The <u>first</u> parameter is the equipment number: EQ.N; the <u>second</u> parameter is the property for control or acquisition, trough a CAMAC unit, of a special parameter of the equipment: PRO

So FUN(EQ.N, "PRO")

for example the function:

- a) SE POW(1, "CCV") = 1000 means <u>write</u> in the register A of a QUAD the value to set 1000 Amps on Power supply 1.
- b) SE CCAV(1)=POW(1, "CCV") means <u>read</u> in a QUAD register B, the current value on Power supply 1 and put this value in the variable CCAV (1).

2. GENERATION OF EM

For this purpose, we need <u>2</u> programs:

- a) Program PROGEN to generate all constants and variables used in the module EM. EX. POWGEN
- b) Program PRO1 to create the properties themselves. EX. POW1

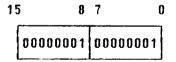
2.1 Description of PROGEN

The variables are grouped in NODAL blocks:

- a) Property block: \$S PROX(K)="PRO...."
- b) Hardware address: SE HALC X(EQ.N)=[[0101

The name of the array for the PRO (perty) and the HALC have to be different for each EM specially when the EM are in the same defined area.

In the 16 bits word HALC, we put 2 addresses: the LOOP number and the CRATE number:



These 2 blocks are always present. The other blocks depend of the module itself. The generation is made by the block director; we have to use <u>different block numbers</u> in the different PROGEN if we want to use many EM in the same console.

Examples:

```
21.01 %**************CONSTANTS GENERATION FOR IVP FUNCTION*******
21.02 %
                       FOR SEPARATOR
21.03 %
21.10 D0 22;D0 23;D0 24;D0 25;D0 28
21.90 % END
22.01 %************DEFINITION OF PROP. IVP********
22.02 %
22.10 DIM-S PROP; SE N. PROP=7
22.15 $$ PROP(1)="$WICHP";$$ PROP(2)="$TAQCP";$$ PROP(3)="$TAQDP"
22.20 $$ PROP(4)="ADRCP";$$ PROP(5)="ADRAP";$$ PROP(6)="ADRBP"
22.25 $S PROP(7)="INITP"
14.02 %
14.10 FOR I=1, N.VAC; SE HALCV(I)=[[0101
14.15 FOR I=1, N.VAC; SE HANAV(I)=[[0400
14.20 FOR I=1,4;SE HABV(I)=(I-1)*2;
14.25 SE HABV(5)=0
14.27 7.
14.90 SE QX=0:SE DX=30:SE DY=7
```

2.2 Description of PRO1

In the first block, we have to test the EQ.N validity and we define the index K corresponding to the property. In the second block, we decode the hardware addresses.

Example:

```
3.01 %**************CHECK OF PARAM. RANGE OF POW-FUN*****************************
3.02 %
3.04 IF EQ.N<1; SE ARG(1)=41;D0 91
3.05 IF EQ.N>N.POW; SE ARG(1)=42; T ! ARG(1);DO 91
3.10 %
3.11 SE K=FIND(PROP, P.PRP)
3.12 IF K<1; SE ARG(1)=43;DO 91
3.13 IF K>N.PRO; SE ARG(1)=44;DO 91
3.90 IF K<>-1; % TY EQ.N PRO(K) K
4.02 %
4.05 SE CN=AND(HALC(EQ.N),[[000F)
4.07 SE LN=SHIFT(HALC(EQ.N),-8)
4.09 SE AN=AND(HANA(EQ.N),[[000F)
4.11 SE NN=SHIFT(HANA(EQ.N),-8)
4.99 % T !!"CRATE-" CN "LOOP"LN "SLOT="NN "QUAD ARD.=" AN
For each property (K), one block is built.
```

for example in POW1, K=6 for property "CCV" 35.02 %********* OR READ LAST CURRENT VALUE IN DATA TABLE********* 35.03 % K=6 "CCV" FLAG=-1 IN WRITE MODE 35.04 % 35.05 % 35.14 IF FLAG=1;GO TO 35.40 35.15 IF VALUE<MIN(EQ.N);SE ARG(1)=47;D0 91 35.17 IF VALUE>MAX(EQ.N); SE ARG(1)=48; DO 91 35.25 SE CCVA(EQ.N)=VALUE 35.26 SE CC=VALUE*SCLW(EQ.N) 35.27 <u>SE SCAM(LN, CN, NN, AN+2, 16, QX)=CC;</u> IF QX<>3; DO 95 35.29 <u>SE TR=SCAM(LN,CN,NN,0,25,QX);</u>IF QX<>3;D0 95 35.30 RETURN 35,40 % FLAG=1 FUNCTION IN MODE READ 35.42 VALUE CCVA(EQ.N) The general procedure for create one EM. is: a) with PROGEN, put the variables in the interactive zone, save them in our file 17 and after load them in defined area: OLD<17>PROGEN; RUN or DO 11 (director block) SAVE<17>DATPRO ALLY LDEF<17>DATPRO b) with PRO1 create the defined function: OLD<17>PR01 DEF-FUN PRO(V.EQ.N.S-P.PRO) (or DO 98)

- c) save all defined area; variables and functions: SDEF<17>FEM
- d) so next time, we can load directly the defined area: LDEF<17>FEM

3. SETTING OF THE DEFINED AREA IN EACH CONSOLE

3.1 CONSOLE 1

It concerns the Vacuum and Tape transport we need IVP, IVV, SADC, TIM, 4 E.M. in the same console.

Procedure for generate 4 E.M.in the same defined area

ZDEF OLD<17> ADCGEN; DO 31 LOAD<17> VACGEN;DO 11 LOAD<17> PUPGEN;DO 21 LOAD<17> TIMGEN;DO 41 SAVE<17>DAT4EM <u>ALLV</u> LDEF<17>DAT4EM

OLD<17> PUP1;D0 98

```
OLD<17> VAC1;DO 98
OLD<17> ADC1;DO 98
OLD<17> TIM1;DO 98
SDEF <17> F4EM
```

3.2 Console 2

It concerns the accelerating devices and ion source; we need POW, SADC.

Procedure for generate 2 EM. in the same defined area:

ZDEF OLD<17> POWGEN;DO 1 LOAD<17> ADCGEN;DO 31 SAVE<17> DAT2EM <u>ALLV</u> LDEF<17> DAT2EM

OLD<17> POW1;D0 98 OLD<17> ADC1;D0 98

SDEF<17> F2EM

3.3 CONSOLE 3

It concerns the power supply of beam transport and extraction electrode movement. We need only POW:

 OLD<17>
 POWGEN; DO
 1

 SAVE<17>
 DAT1EM
 ALLV

 LDEF<17>
 DAT1EM
 OLD

 OLD<17>
 POW1; DO
 98

SDEF<17> F1EM

So at each time, we <u>switch on</u> the console, we have to load FNEM in the function area, ex: LDEF<17>F2EM for console 2. This instruction is put in the INIT program. For each modification in one E.M., we have to <u>rebuilt</u> the defined area by the complete procedure described before.

4. LIST OF PROPERTIES

A) <u>POW= POWER SUPPLY</u>

SE ST=POW(EQ.N,"PROW") Read Mode R SE POW(EQ.N,"PROW")=Value Write Mode W Camac Unit: (QUAD + Single Transceiver)

PROW	Mode	Value	Description	
OFFQUAD	W	0	One QUAD chanel "OFF" only for EQ.N	
	R	1	The status of each chanel for QUAD NN	
POWER	W	1/0	Supply ON = 1 " OFF = 0 The status is kept	
STBY	W	0	Supply STBY = 0 in Data Table	
RSET	W	0	" $RSET = 0^{J}$	
CCAD	W	HEXA	W Status in Reg.A1 in digital [[01 = OFF [02 = STBY [04 = ON	
	R	1	Read the last status in Data Table	
ccv	W	Numb.	Load Reg.B with N for equipment EQ.N (Reg.B)	
	R	1	Read the last value in Data Table	
CCVD	W	HEXA	Write a value in digital in Reg.B	
SAQD	R	1	Read Reg.C : status of the equipment	
AQN	R	1	Read Reg.D + scaling factor = Physical Value	
AQND	R	1	Read Reg.D : Value in digital	
ADRC	W	HEXA	Write LOOP and Crate address ex [[0101	
	R	/	Read L and C address in digital (data table)	
ADRA	W	НЕХА	Write N slot and A Subaddress of QUAD ex. [[040A slot 4, chanel 4 of QUAD	
	R	1	Read N and A in HEXA in Data Table	
MAXV	W	Numb. in	Write Maximum Value for equipment in data table	
	R	Amp	Read Maximum Value for equipment in data table	
MINV	W	Numb. in	Write Minimum Value for equipment in data table	
	R	Amp	Read Minimum Value for equipment in data table	
				/

PROW	Mode	Value	Description
SCLR	W		/ Write scaling factor for DAC used in data table
	R	1	Read scaling factor for DAC used in data table For 12 bits DAC = 2.442
SCLW	W	Numb.	Write scaling factor for ADC used in data table
	R	/	Read scaling factor for ADC used in data table For 12 bits ADC = 0.409
INITL	R/W	/	Initialisation of QUAD Slot N All Reg. of all chanel at zero
"DELTV"	W	Numb.	Write the variation of Physical value in <u>pourcent</u>
	R		Read the pourcent admitted in data table

B) <u>SADC = SCANNING ANALOG TO DIGITAL CONVERTER</u>

SE PHV(EQ.N)=SADC(EQ.N, "PROM")	Read Mode	R
SE SADC(EQ.N,"PROM")=Value	Write Mode	W
Camac Unit: Scanning ADC + N x MUX		

PROM	Mode	Value	Description
AQRAND	R	1	Read <u>a</u> physic value PHV in MUX chanel (EQ.N) Only <u>one</u> chanel
AQSCAN	R	1	Read from starting chanel = EQ.N to the last chanel <u>all the PHV (N)</u>
ADRCM	W	HEXA	Write LOOP and Crate adress in data table
	R	1	Read LOOP and Crate adress in the data table
ADRAN	W	HEXA	Write Slot and chanel for MUX for each EQ.N in data table
	R	1	Read Slot and chanel for MUX for each EQ.N in data table
ADRADC	W	HEXA	Write the number of chanel and Slot addr. of ADC in D.T.
	R	1	Read the number of chanel and Slot addr. of ADC in D.T. ex [[1F0A means 32 chanels (2MUX) + ADC in slot 10
SMRMU	W	Numb.	Write scaling factor for PHV (EQ.N)
	R		Read scaling factor for PHV (EQ.N)

C) IVV : ISOLDE VACUUM VALVES

SE ST.IVV(EQ.N,"PROV") Read Mode R SE IVV(EQ.N,"PROV")=Value Write Mode W Camac Unit: QUAD + Single Transceiver

PROV	Mode	Value	Description
SWITCHV	W R	0/1	Close = 0 or Open = 1 a Valve (EQ.N) Read the last action in Reg.A on Valve
STAQCV	R		Read Reg.C, the status of the valve
LOCAL	R		Read Reg.D, LOCAL = 1 Remote = 0
ADRCV	W R		Write Loop and Crate address Read Loop and Crate address
ADRAV	W R	HEXA /	Write Slot and subaddress of QUAD [[0400 Read Slot and subaddress of QUAD on DaTa Table
ADRBV	W R	Numb.	Write the bit address for value EQ.N in Reg.A1 + A2 Read the bit address for value EQ.N in data table
INITV	R		Initialis. of QUAD slot N, all Reg. of all chanel at zero

D) IVP = ISOLDE VACUUM PUMPS

SE ST=IVP(EQ.N,"PROP")	Read Mode	R
SE IVP(EQ.N,"PROP")=Value	Write Mode	W
Camac Unit : QUAD + Single	Transceiver	

PROP	Mode	Value	Description
SWITCHP	W	0/1	Stop = 0 or Start = 1 a Pumps (EQ.N)
	R		Read the last action in Reg.A on Pumps
STAQCP	R		Read Reg.C : status of the Pumps
STAQDP	R		Read Reg.D : Vacuum status + Local + Pumps status
ADRCP	W	HEXA	Write Loop and Crate address
	R	1	Read Loop and Crate address in data table
ADRAP	W	HEXA	Write Slot and subaddress of QUAD
	R	1	Read Slot and subaddress of QUAD in data table
ADRBP	w	Numb.	Write the bit address for Pump EQ.N in Reg.A1 + A2
	R		Read the bit address for Pump EQ.N in data table
INITP	W		Initialisation of QUAD Slot N
			All Reg. of all chanel at zero

SE ST=TIM(EQ.N,"PROT") Read Mode R SE TIM(EQ.N,"PROT")=Value Write Mode W Camac Unit : Preset Counter G.P.P.C.

PROT	Mode	Value	Description
AQN	R	Numb. of Pulse	Read Preset Register
ccv	W	Numb. of	Load Preset Register in start external Mode
	R		Read last Preset counter value in data table
TRAIN	W/R		Choose Train C = external CRK
ADRCT	W R	HEXA /	Write Loop and Crate address ex [[0101 Read Loop and Crate address in data table
ADRAT	W R		Write N Slot and A subaddress of PC.CV[[0B01 Read N Slot and A subaddress in data table
MAXV	W	Numb. of	Write Maximum number of pulse train Mot 15 bit + signe ==> 32767
	R	Pulse	Read Maximum number of pulse train in data table
MINV	W	Numb. of	Write Minimum number of pulse train
	R		Read Minimum number of pulse train in data table
INITT	W/R		Initialise both P.C.
TRIG			Produces an immediate output
STAQ	R	HEXA	Read the status register (Choose of Train in 3 first bits, Gate and so On)

ANNEXE 3

TESTING WITH MACINTOSH

For a better understanding, it is advisable to read ANNEXE 2 before (Sorry !)

For easy use of Mac Intosh, we have stored in <u>defined area</u> the E.M. needed for each crate. We don't explain the details of this packed software, everything is in Annexe 2, we use the same program name for simplicity. As only difference, we store all programs and systems on the Mac disk instead of the file <17>.

Example of procedure the first time:

ZDEF OLD POWGEN; RUN SAVE DATPOW <u>ALLV</u> LDEF DATPOW OLD POW1 DEF. FUNPOW(V-EQ.N, S-P.PRO) SDEF FPOW

If no modification are needed, at each switch off, type LDEF FPOW. Same procedure when printing NODAL.

- A) Use of E.M. in Mac Intosh
- 1) You can type the complete instruction: ex SE POW(10,"POWER")= 0 or 1 means put power supply 10 ON or OFF
- If you don't want know anything about CAMAC, we can elaborate a <u>little</u> <u>application</u> program for your <u>special test</u> and you choose all the possibilities with <u>the Mouse</u>.

B) Example of Program

choice of status choice of current value choice of Reg. reading initialisation of a QUAD 10.01 %*********INIT.MENU FOR ISOLDE POWER SUPPLY********* 10.02 % 10.10 SE QUIT.=0 10.11 SE MENU.=0;SE ITEM.=0 10.12 \$S MENU(1,0)="STAT.CTRL" 10.16 \$S MENU(1,1)="POWER STBY" 10.18 \$\$ MENU(1,2)="POWER ON" 10.20 \$\$ MENU(1,3)="POWER OFF" 10.22 \$\$ MENU(1,4)="POWER RSET" 10.24 \$S MENU(2,0)="CRT.CTRL" 10.26 \$\$ MENU(2,1)="IN AMPERES" 10.28 \$\$ MENU(2,2)="IN DIGITAL" 10.30 \$\$ MENU(3,0)="INI.QD"

```
10.32 $$ MENU)3,1)="INITL"
10.40 $$ MENU(4,0)="READ.REG,"
10.42 $$ MENU(4,1)=" REG C"
10.44 $S MENU(4,2)=" REG D"
10.50 T!" USE MOUSSE FOR POWER SUPPLY TEST"
10.80 WH QUIT.=0; DO 16
14.02 %
14.12 IF ITEM.=3;SE ST=0;SE POW(I, "POWER")=ST
14.14 IF ITEM.=2;SE ST=1;SE POW(I. "POWER")=ST
14.16 IF ITEM.=1;SE ST=1;SE POW(I, "STBY")=ST
14.18 IF ITEM.=4;SE POW(I, "RSET")=8;
16.02 %
16.10 SE SEL.=MHIT(MENU., ITEM.)
16.12 IF MENU.=2; IF ITEM.=1; DO 17
16.14 IF MENU.=1;D0 14
16.16 IF MENU.=2; IF ITEM.=2; DO 18
16.18 IF MENU.=3; IF ITEM.=1; SE POW(1, "INITL")=0; SE POW(5, "INITL")=0
16.20 IF MENU.=4; IF ITEM.=1; DO 20
16.22 IF MENU.=4; IF ITEM.=2; DO 22
17.02 %
17.10 T! TYPE SUPPLY NUMB= ";ASK N
17.20 T! TYPE CURRENT IN AMPS= ";ASK C
17.30 SE POW(N, "CCV")=C
17.40 T! " VERIFY ON THE SUPPLY IF THE CURRENT IS THERE!!"
18.01 %***********ENTER EQ.N DIGITAL NUMBER****
18.02 %
18.10 T! TYPE SUPPLY NUMB= ";ASK N
18.20 T! TYPE CURRENT IN HEXA= ";ASK C
18.30 SE POW(N, "CCV")=C
18.40 T! " VERIFY ON THE SUPPLY IF THE CURRENT IS THERE !!"
20.02 %
20.10 T! "TYPE NUM. SUPPLY= " ;ASK N
20,14 SE ST=POW(N, "SAQD"); T! "REG C=" ST
22.01 %*********READ REGISTER D****************
22.02 %
22.10 T! "TYPE NUMB. SUPPLY= " ; ASK N
22.14 SE ST=POW(N, "AQN"); T! "REG D=CURRENT" ST
```

ANNEXE 4

NAMING STRUCTURE FOR ISOLDE 3 COMPONENTS

1) INTRODUCTION

The naming structure for ISOLDE 3 is based on the so-called Oscar Barbalat standard (abbreviated in O.B. name) introduced some years ago and now used in most of the PS systems.

For each element of Isolde 3 we propose to use a name composed of three groups of characters:

IX.YYYYNN

- the first two characters, IX, represent the process and sub-process. In our case the process is always I for ISOLDE;
- the next group, YYYY, up to 4 characters, represents a contracted but (hopefully!) meaningful description of the element in object;
- the third group, NN, optional, is a progressive numerotation for elements of the same kind.
- <u>Remark 1</u>: the following list of names concerns only those elements that are controlled by computer (identified up to now): we think it should be extended later to cover all parameters of the ISOLDE 3 project.
- <u>Remark 2</u>: in case of progressive numerotation, NN is intended to start with O1 assigned to the element nearest to the source and so increasing towards the Proton Hall.

2. PROCESS AND SUBPROCESS

We have identified 4 sub-processes:

- IT target + source complex
- IL beam line
- IX timing system
- ID beam disgnostics

3. LIST OF ISOLDE 3 NAMES

Using the previous naming structure, the proposed names list follows. Parameters are grouped per system as they have been identified during the computer control meetings in the past months.

A. Vacumm system

IL.VALV01	(to	12)	vacuum valves
IL.PUMP01	(to	??)	vacuum pumps
IL.VPIR01	(to	??)	Pirani gauges
IL.VPEN01	(to	??)	Penning gauges

B. <u>HT inside the Faraday cage (60 KV)</u>

IT.GOHT	high tension power supply
IT.VROU	voltage on rough PS
IT.IROU	current on rough PS
IT.IREF	current in reference PS
IT.VSTB	voltage on stabilizer

C. Insulating transformer

IS.TRFO

D. <u>Target and ion source</u>

IT.VPEX IT.IPEX	pre-extractor PS pre-extractor current
IT.VAN(01 to 02) IT.IAN(01 to 02)	anode PS anode current
IT.VSMG	source magnet PS
IT.ISMG	source magnet current
IT.VTAR	target PS
IT.ITAR	target current
IT.VOVE	oven PS
IT.IOVE	oven current
IT.VLHE	line heating PS
IT.ILHE	line heating current
IT.VELB	electron bombardement PS
IT.IELB	electron bombardement current
IT.VFIL	filament PS
IT.IFIL	filament current
IT.ISS	ion source status
IT.TEMP(01 to 06)	temperature measurements

E. <u>Beam transport</u>

IL.QP(01 to 29)	electrostatic quadrupoles PS
IL.XYH(01 to 18)	horizontal dipoles PS 👔 x y
IL.XYV(01 to 18)	vertical dipoles PS 🌙 plates
IL.BEND(01 to 02)	bending PS
IL.MAG(01 to 02)	analysing magnet PS
IL.MASS	mass specification (user)

F. Extraction electrodes

IL.EEZ	extr. el. longitudinal movement
IL.EEX	extr. el, transversal(x) movement
IL.EEY	extr. el. transversal(y) movement

G. <u>Measurement systems (beam diagnostics)</u>

ID.TAPE(01 to ??) IX.TAPE(01 to 10) ID.CUP ID.HALL ID.SCAN(01 to ??) ID.SLIT(01 to ??) ID.GRID(01 to ??) tape transport parameters tape transport timings faraday cup hall plate scanners slits grids

8.W.Allardyce, PS O.Barballat, PS G.Baribaud, PS R.Billinge, PS G.Daems, PS A.Daneels, PS K.Gase, PS W.Heinze, PS P.Heymans, PS T.Jené, PS O.Jonsson, EP H.J.Kluge, EP M.Knipfel, (Strasbourg) E.Kugler, EP B.Kuiper, PS H.Lustig, PS F.Perriollat, PS H.Ravn, EP Cl.Richard-Serre, EP Ch.Serre, PS G.Shering, PS S.Sundell, EP B.Vosicki, EP